

# TI Designs

## Single-Phase AC and DC Power Monitor with Wire Resistance and EMI Capacitor Compensation



### TI Designs

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### Design Resources

- [TIDM-SERVER-PWR-MON](#) Design Page
- [MSP430i2040](#) Product Folder
- [EVM430-i2040SUBMTR](#) EVM Folder



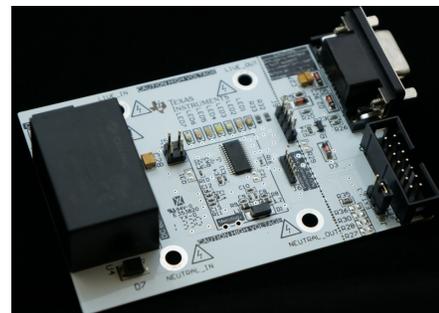
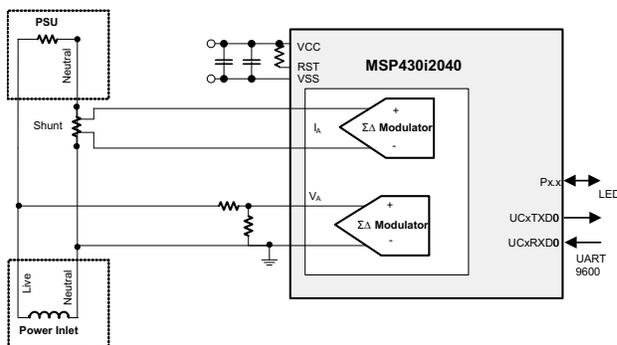
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### Design Features

- Measurement of
  - Voltage: Root Mean Square, THD, Fundamental
  - Current: Root Mean Square, THD, Fundamental
  - Power: Active, Reactive, Apparent, Fundamental Active
  - AC Frequency, Power Factor
- Measures Signal Phase AC and DC and Capable of Switch Between AC and DC Mode Automatically
- Capable of Doing EMI Filter Capacitor and Wire Resistance Compensation
- No Separate DC Calibration Required
- Readings Update Every Four AC Cycles or 80 ms in Case of DC Input
- Spy-Bi-Wire Debugging Interface
- Built-In Switching Mode Power Supply, RS-232 External Communication Interface, 7-in LEDs

### Featured Applications

- Home Appliances
- UPS, Server, and PC Power Supplies
- Smart Plugs or Power Strip
- Solar Energy Inverter
- Electrical Vehicle Charger
- Home Monitoring, Security, and Automation



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# 1 System Description

## 1.1 Cautions and Warnings

The EVM is designed to operate from AC supply or high voltage DC supply by professionals who have received appropriate technical training. Please read the safety related documents that come with the EVM package and user's guide before operating the EVM.



**CAUTION**

Read user guide before use.



**CAUTION**

Do not leave the EVM powered when unattended.



**CAUTION**

HOT SURFACE: Contact may cause burns. Do not touch.



**CAUTION**

HIGH VOLTAGE: Electric shock possible when connecting board to live wire. The board should be handled with care by a professional. For safety, use isolated equipment with overvoltage and overcurrent protection.

This document discuss an application of a single-phase AC and DC power monitor (or server power monitor) using a simple, low-cost Texas Instruments MCU MSP430i2040. The MSP430i2040 is a mixed signal microcontroller. The MCU integrates with four differential input 24-bit sigma-delta (SD24) A/D converters (ADCs) with programmable gain amplifier, a 16-bit hardware multiplier, an SPI communication interface, and an eUSCI\_A0 supports UART. The eUSCI\_B0 supports SPI, I2C, two 16-bit timer, and 12 GPIO pins in a 28-pin TSSOP or 16 GPIO pins in a 32-pin QFN package. The peripheral set is a good combination to measure electrical power.

This document uses the default firmware and the original EVM hardware design to describe the setup, operations, features, behaviors, functions, and interfacing. Proper functionality is not guaranteed if changes made to hardware or firmware.

For more information about the EVM, see the EVM430-i2040SUBMTR User's Guide.

## 2 Design Features

### 2.1 Basic Operations

This design uses three SD24 ADCs on the MCU: one to measure voltage, one to measure current, and the other one connects to the built-in temperature sensor to measure temperature. The sigma-delta ADC runs approximately at a 1.024-MHz modulator frequency fixed by the hardware. The sample frequency derives from the modulator frequency divided by 128 equals 8 kHz, which give us a Nyquist bandwidth of 4 kHz. This bandwidth is sufficient to cover the 66<sup>th</sup> harmonic for 60-Hz AC. The 80<sup>th</sup> harmonic for 50-Hz AC frequency as a wider bandwidth is usually needed for server power monitoring due to the nature of the switching power supplies.

Figure 1 shows the system functional diagram. The two SD24 ADCs take samples from the voltage and the current channel with the (calibrated and programmed) fractional delay. The samples then pass through a DC removal filter. Each DC removal filter dynamically tracks the DC offset of the ADC and the signal by analyzing each sample and removes the DC (from signal and from ADC-DC offset) before passing the sample to further processing. If the operation is in DC mode, the DC removal filter only removes the DC offset of the ADC.

The current sample and the voltage sample then performs a square and accumulates to get the root mean square current ( $I_{RMS}$ ) and voltage ( $V_{RMS}$ ). The current sample also multiplies and accumulates with the voltage sample with proper additional phase delay (if needed) to get the active power ( $P_{active}$ ) and with the corresponding 90-degree shifted sample to get the reactive power ( $P_{reactive}$ ). The EVM then uses an internally generated pure sine wave amplitude and phase synchronized with the AC voltage input together with the 90 degree-shifted version to multiply and accumulate with the current sample to get the fundamental active and fundamental reactive power.

The cycle detection mechanism detects the presence of an AC signal by checking the number of zero crossings over a pre-defined time. If the number of zero crossings is less than the expected number of zero crossings minus 1, then the cycle is in DC mode; otherwise, the cycle is in AC mode. This mechanism works well for the frequency from 25 Hz when the pre-defined determination interval is set to 80 ms.

After four AC cycles (or 80 ms in DC mode), the system sets a flag to show results that need to process. The flag then triggers this system to perform the scaling and convert these accumulated values into values of proper unit (V, A, W, and so on).

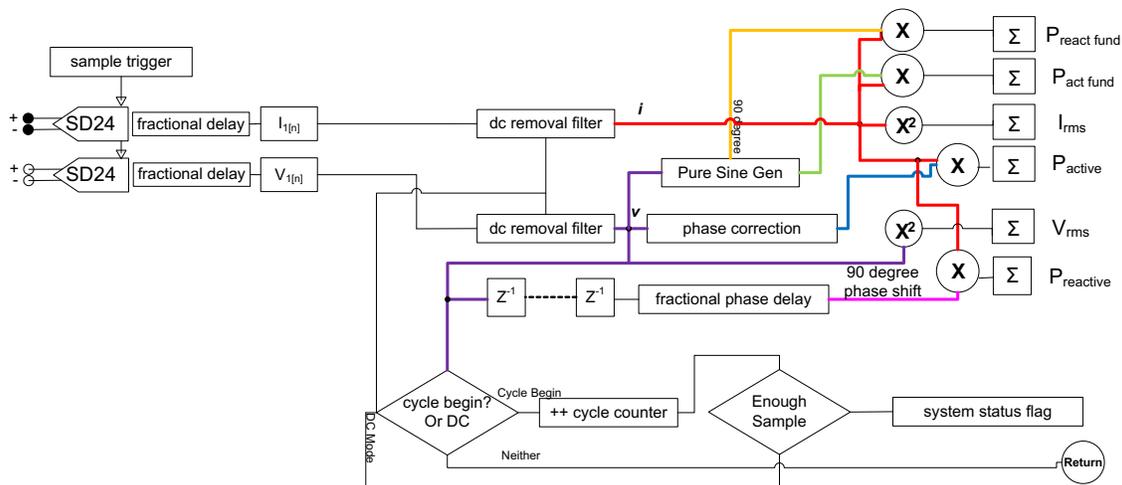
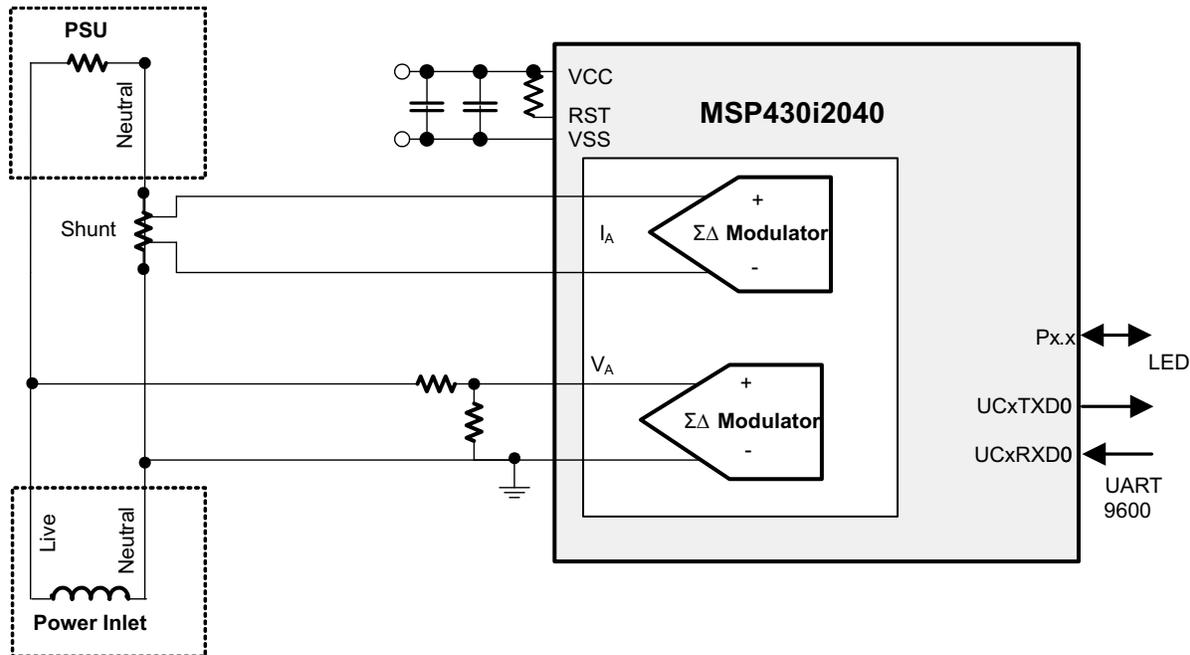


Figure 1. System Functional Diagram

### 3 Block Diagram



**Figure 2. System Block Diagram**

#### 3.1 Interface Circuit

The key factor of a successful and accurate metering circuit design very much depends on a good sampling circuit. The 24-bit sigma-delta ADC on the MSP430i2040, together with the on-chip programmable gain amplifier, provides the critical hardware for getting high quality AD conversion results from both the current and voltage sensor. Moreover, the interface circuit, the component selection, and the circuit layout also play a crucial role for a successful design.

Due to the nature of a sigma-delta ADC and of the voltage and current signals being measured, an external interface circuit is needed to interface the voltage and current to keep the sigma-delta ADC to work properly and provide proper filtering for a band of interest.

The hardware of the interface circuit consists of simple, passive components apart from the protection diode. [Figure 3](#) shows the interface circuit designed. The top circuit is the interface to the voltage sensor and the bottom circuit is for the current sensor (or the shunt resistor).

In the current sensor interface circuit with R6 being the shunt sensor, D1 is the optional protection diode. The protection diode is not required unless, for example, a high shunt resistor value or a current transformer is in use instead of the current sensor, and the user anticipates a significant current surge to cause enough voltage across the sensor to damage the MCU.

L1, R9, and C9 forms a low pass filter having a bandwidth of a few MHz. The purpose of this filter is to reject radio frequency interference from going into the sigma-delta ADC. The filter formed by L2, R8, and C8 has the same characteristic, which is balanced for the differential signal. The filter formed by R9, R8, and C10 is a filter that gives a bandwidth of about 10 kHz, which is the filter for the band of interest.

The order of magnitude of these capacitors should be observed although the actual value of the capacitance is not that critical.

The voltage sensor interface is a resistor ladder. The ratio of the resistance in the resistor ladder allows up to 308-V AC and 420-V DC to be measured. The current sensor filter is similar except that the value of R10 is 100 Ω, not 1 kΩ. The reason for this is the voltage divider circuit has an equivalent source

resistance  $1.5k \times \frac{990k}{(1.5k+990k)} = 1.5k$  in series with R10. To balance the filter for the differential signal, the sensor uses a small R10 value. The combined effect is of similar value to R11. Although there is a slight mismatch using the designed value, this effect has no observable impact to accuracy.

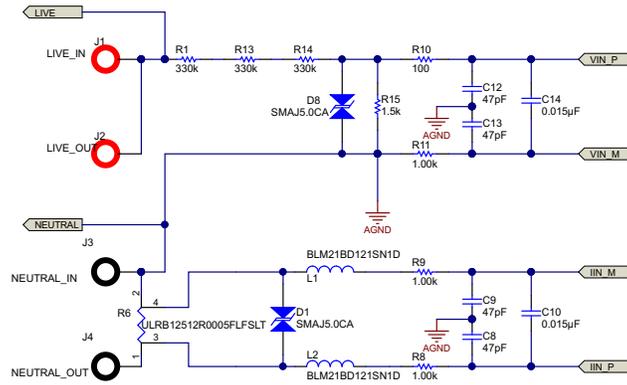


Figure 3. Voltage and Current Sensor Interface Circuit

### 3.2 Component Considerations

#### 3.2.1 Shunt Resistor

For accurate measurements, the choice of shunt is another important factor. In practice, a shunt of smaller value is a better choice. Smaller shunt values benefit the power dissipated on the shunt and the respective rise in temperature. The lower rise in temperature reduces the need for a very low temperature coefficient shunt resistor to sustain accuracy. However, using a small value shunt has a drawback as well in that the signal-to-noise ratio (SNR) of a small value shunt is worse than using a larger value one. In this sense, there may be chance that a shunt of higher value is desired, for example when measuring a very small current and the range of current to be measured are also in a small range. Consider these factors for this design: the maximum current, the current dynamic range, and the power dissipation.

In this application, the maximum current for each socket is 15 A, and the desired dynamic range of current keeping flat error percentage is 1000:1. Keep the power dissipated on the shunt resistor as small as possible.

To achieve the best accuracy, have the shunt sensor signal use the whole input range of the SD24. Because the SD24 ADC has an input range of 900 mV at x1 gain, using a x16 gain the input range is

$$\frac{\left(\frac{900}{16}\right)}{\sqrt{2}} = 39.77 \text{ mV}_{\text{RMS}} \tag{1}$$

With this number, a 2-mΩ shunt resistance suits this input up to 19.5 A. Due to the limited area of copper attached to the shunt resistor, however, use a smaller valued shunt to keep the heat accumulation on the shunt resistor low, then choose a 0.5-mΩ shunt resistance.

In addition to value, the physical size of the shunt is also an important factor to accuracy—not the size directly, but the heat generated when current flows. A smaller sized shunt heats up more easily due to the limited surface area. If there is significant current to flow through the shunt, have a large enough sized shunt and sufficient ventilation on the PCB to prevent heat being accumulated. In this design, a 2512 size shunt is chosen. At 0.5-mΩ, the power dissipated on the shunt at maximum current is  $16^2 \times 0.5 = 0.128 \text{ W}$ , which is about one-eighth the rated power of a 2512 size 1-W shunt resistor.

### 3.2.2 Voltage Divider Circuit

For the voltage sensor circuit, the matter is a little simpler. In this design, the major consideration is that the voltage divider should be able to prevent arcing between the terminals. To reduce the voltage difference between resistor terminals, this design uses four resistors (instead of 2) to form the voltage divider (R1, R13, and R14 are 330 k $\Omega$ , and R15 is 1.5 k $\Omega$ ). Then the voltage across R1, R13, and R14 each take about one-third of the AC voltage. Now at 220-V input, each resistor has a voltage drop of about 75 V. Using the 2512 resistor for R1, R13, and R14 then further separate the live voltage and R15.

The installation of D8 in the voltage sensor circuit is more important than D1 in the current circuit. The reason is that the resistor ladder on the voltage sensor circuit is more likely to see a voltage surge across R15 high enough to damage the MCU. If R15 is open circuit or in bad contact, causing a higher resistance the voltage across the input of the voltage channel ADC also damages the MCU.

## 4 Software Description

### 4.1 Firmware Structure

The firmware is designed to use a layered approach, isolating the user from the details of metrology and the associated computations involved to simplify the programming work.

In user's view, the firmware is partitioned into three main blocks:

- The application, which contains the function to perform system setup and initialization, main loop, communication protocol and command handling, non-volatile parameters preset, and manipulation.
- The toolkit packaged, which is packed into a library named "emeter-toolkit-i2041.r43", contains low-level computation routines.
- The metrology computation engine, which is packaged into a library named "emeter-metrology-i2041.r43", contains the function for ADC setup and initialization, sample-based background processing, reporting cycle-based foreground processing, and result reading API.

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**NOTE:** This package does not include the source code of this library. Contact a local Texas Instruments Sales Team if the source code is needed.

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## 4.2 Metrology Computation Engine

The metrology computation engine performs the actual sampling and computation based on the information collected from the voltage and current ADC channels. The engine acts in a time-critical background process and a less time-critical foreground process.

The background process is triggered by the ADC at the sample rate. This process runs in the interrupt services routine of the ADC and is processed automatically.

The foreground process is triggered by the completion of background process at the reporting and update rate. The background process sets the flag PHASE\_STATUS\_NEW\_LOG in the variable phase\_state to indicate that data is ready to be processed by the foreground. The application then needs to monitor this flag to trigger the foreground process by calling to calculate\_phase\_readings ().

In the actual computation, use the following formulas in the metrology computation:

$$V_{\text{RMS}} = \text{VGAIN} \times \sqrt{\frac{1}{N} \sum_{i=1}^N V_{\text{samp}(i)} \times V_{\text{samp}(i)}} \quad (2)$$

$$I_{\text{RMS}} = \text{IGAIN} \times \sqrt{\frac{1}{N} \sum_{i=1}^N I_{\text{samp}(i)} \times I_{\text{samp}(i)}} \quad (3)$$

$$P_{\text{active}} = \text{PGAIN} \times \frac{1}{N} \sum_{i=1}^N V_{\text{samp}(i)} \times I_{\text{samp}(i)} \quad (4)$$

$$P_{\text{reactive}} = \text{PGAIN} \times \frac{1}{N} \sum_{i=1}^N V_{\text{samp},90(i)} \times I_{\text{samp}(i)} \quad (5)$$

$$P_{\text{apparent}} = V_{\text{RMS}} \times I_{\text{RMS}} \quad (6)$$

$$\text{PF} = \cos\phi = \frac{P_{\text{active}}}{P_{\text{apparent}}} \quad (7)$$

$$V_{\text{RMS fund}} = \text{VGAIN} \times \sqrt{\frac{1}{N} \sum_{i=1}^N V_{\text{samp}(i)} \times V_{\text{pure}(i)}} \quad (8)$$

$$P_{\text{active fund}} = \text{PGAIN} \times \frac{1}{N} \sum_{i=1}^N I_{\text{samp}(i)} \times V_{\text{pure}(i)} \quad (9)$$

$$P_{\text{reactive fund}} = \text{PGAIN} \times \frac{1}{N} \sum_{i=1}^N I_{\text{samp}(i)} \times V_{\text{pure}(\pi/2)(i)} \quad (10)$$

$$V_{\text{THD}} = \frac{\sqrt{V_{\text{RMS}}^2 - V_{\text{RMS fund}}^2}}{V_{\text{RMS fund}}} \quad (11)$$

$$I_{\text{RMS fund}} = \frac{\sqrt{P_{\text{active fund}}^2 + P_{\text{reactive fund}}^2}}{V_{\text{RMS fund}}} \quad (12)$$

$$I_{\text{THD}} = \frac{\sqrt{I_{\text{RMS}}^2 - I_{\text{RMS fund}}^2}}{I_{\text{RMS fund}}} \quad (13)$$

#### 4.2.1 Background Process

The background performs a straight-forward, time-critical, sample-based process. The process starts by an interrupting trigger at the sample rate. The background process then

- Captures data from voltage and current ADC channels
- Performs voltage sample processing and line resistance compensation
- Performs current sample processing and capacitance compensation
- Performs power processing
- Performs fundamental power processing
- Performs line frequency processing and AC/DC mode test and switching
- Triggers the foreground process

#### 4.2.2 Foreground Process

After reaching the report cycle, the background sets the flag `PHASE_STATUS_NEW_LOG`. The user main loop checks the status of this flag and calls to the foreground process `calculate_phase_readings ()` to perform the rest of the computation and deliver the measurement readings, including

- Power processing
  1. Calculate active power and reactive power
  2. Calculate fundamental active and fundamental reactive power
- Voltage processing
  1. Calculate the RMS voltage and fundamental RMS voltage
- Current processing
  1. Calculate the RMS current and fundamental RMS current
  2. Calculate the apparent power
- Other processing
  1. Calculate the power factor
  2. Calculate the frequency of the AC line

## 5 Test Setup

### 5.1 Apparatus

The following list of instruments help calibrate and test the EVM (See the instrument link in [Section 8](#)):

- AC meter test set
- AC source that could output sufficient power to drive the load at a rated frequency (for example, 50 to 60 Hz) and a rated voltage (for example, 110 to 220 V) with a variable AC load or UUT. If DC measurement is needed, use a variable DC load or UUT. Alternatively, an AC test set could generate the rated loading
- A reference meter that could read AC parameters based on the voltage, current, and phase setting from the AC meter test set

### 5.2 Setup

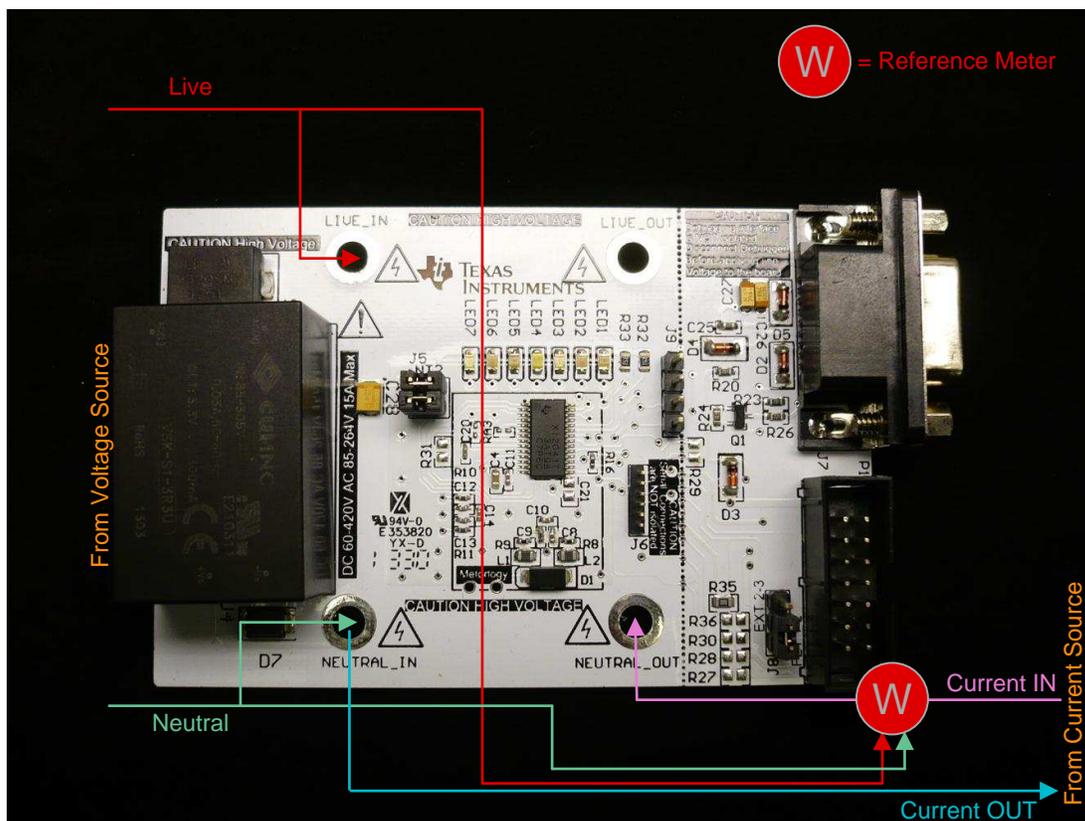


Figure 4. Setup

## 6 Test Results

**Table 1. Output C PF = 1, Cal at 7.50212 A, 1650.7 W**

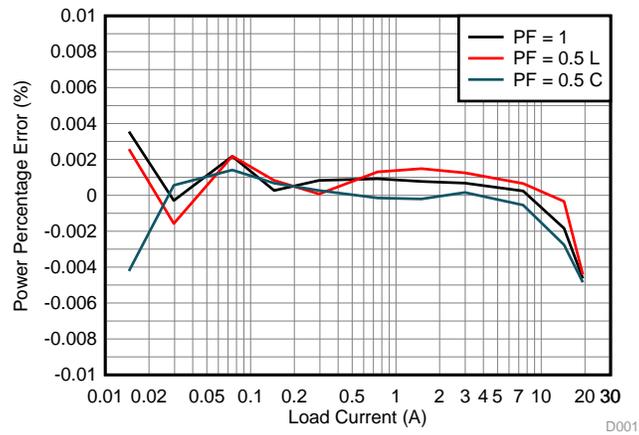
CURRENT REF	CURRENT READ	CURRENT ERROR	CURRENT %	POWER REF	POWER READ	POWER ERROR	POWER %
0.014555	0.01476	0.000205	1.408%	3.202	3.213	0.011	0.355%
0.029637	0.029737	0.0001	0.339%	6.517	6.515	-0.002	-0.029%
0.074836	0.07495	0.000114	0.152%	16.579	16.615	0.036	0.217%
0.145378	0.145391	0.000013	0.009%	31.984	31.992	0.009	0.027%
0.295964	0.295992	0.000028	0.009%	65.114	65.168	0.054	0.083%
0.747332	0.747569	0.000237	0.032%	165.104	165.256	0.152	0.092%
1.50005	1.5	-0.00005	-0.003%	330.06	330.314	0.254	0.077%
2.98846	2.989	0.00054	0.018%	662.136	662.586	0.45	0.068%
7.50239	7.5	-0.00239	-0.032%	1650.38	1650.779	0.399	0.024%
14.35	14.32	-0.03	-0.209%	3090.24	3084.544	-5.696	-0.184%
19.3214	19.242	-0.0794	-0.411%	4162.29	4143	-19.29	-0.463%

**Table 2. Output C PF = 0.5 L, Cal at 7.50212 A, 1650.7 W**

CURRENT REF	CURRENT READ	CURRENT ERROR	CURRENT %	POWER REF	POWER READ	POWER ERROR	POWER %
0.014558	0.014654	0.000096	0.659%	1.555	1.559	0.004	0.257%
0.029628	0.029774	0.000146	0.492%	3.173	3.168	-0.005	-0.158%
0.074823	0.074824	0.000001	0.001%	8.037	8.055	0.018	0.218%
0.145166	0.145141	-0.000025	-0.017%	13.287	13.298	0.011	0.083%
0.295495	0.295481	-0.000014	-0.005%	27.587	27.589	0.002	0.007%
0.747391	0.747393	0.000002	0.000%	71.399	71.492	0.093	0.130%
1.5001	1.5	-0.0001	-0.007%	165.134	165.379	0.245	0.148%
2.98839	2.989	0.00061	0.020%	319.346	319.745	0.399	0.125%
7.40232	7.4	-0.00232	-0.031%	596.562	596.954	0.392	0.066%
14.3712	14.354	-0.0172	-0.120%	890.268	889.965	-0.303	-0.034%
20.0216	19.914	-0.1076	-0.537%	2197.23	2187.52	-9.710	-0.442%

**Table 3. Output C PF = 0.5 C, Cal at 7.50212 A, 1650.7 W**

CURRENT REF	CURRENT READ	CURRENT ERROR	CURRENT %	POWER REF	POWER READ	POWER ERROR	POWER %
0.014543	0.014671	0.000128	0.879%	1.659	1.652	-0.007	-0.422%
0.029624	0.029638	0.000014	0.046%	3.388	3.39	0.002	0.056%
0.074827	0.074848	0.000021	0.029%	8.525	8.537	0.012	0.141%
0.145314	0.145267	-0.000047	-0.032%	18.491	18.503	0.012	0.068%
0.295834	0.295752	-0.000082	-0.028%	37.381	37.391	0.01	0.027%
0.747077	0.747067	-0.00001	-0.001%	94.044	94.03	-0.014	-0.015%
1.48145	1.481	-0.00045	-0.030%	171.561	171.526	-0.035	-0.020%
2.98851	2.989	0.00049	0.016%	345.256	345.311	0.055	0.016%
7.40175	7.399	-0.00275	-0.037%	1025.61	1025.054	-0.556	-0.054%
14.3347	14.318	-0.0167	-0.117%	2196.37	2190.308	-6.062	-0.276%
19.304	19.241	-0.063	-0.326%	2965.78	2951.4	-14.38	-0.485%



**Figure 5. Power Percentage Error versus Load Current**

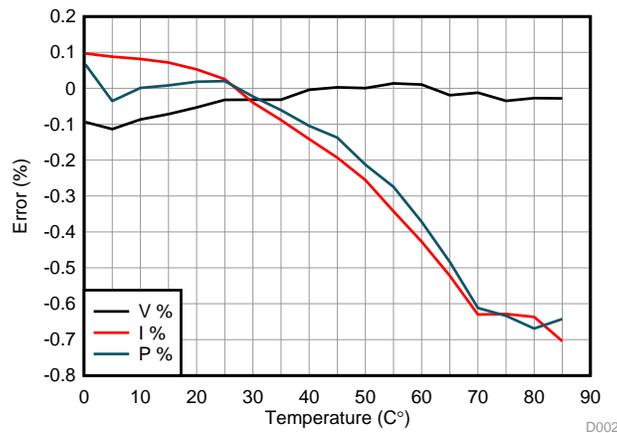
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**NOTE:** From the above graph, the error begins to go negative the higher current. This phenomenon is due to the shunt heating up by the current flowing through the traces on the board. At a low current, the higher error is mostly caused by noise, causing unstable readings.

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**Table 4. Typical Accuracy versus Temperature**

TEMP (°C)	VOLTAGE (V)			CURRENT (A)			POWER (W)		
	V	V <sub>REF</sub>	V%	I	I <sub>REF</sub>	I%	P	P <sub>REF</sub>	P%
0	219.786	219.991	-0.093%	5.005	5.000	0.097%	1100.730	1099.940	0.072%
5	219.728	219.978	-0.114%	5.005	5.000	0.088%	1099.470	1099.860	-0.035%
10	219.801	219.992	-0.087%	5.005	5.000	0.082%	1100.050	1100.040	0.001%
15	219.839	219.997	-0.072%	5.004	5.000	0.072%	1100.110	1100.020	0.008%
20	219.896	220.013	-0.053%	5.003	5.000	0.053%	1100.120	1099.920	0.018%
25	219.883	219.954	-0.032%	5.002	5.000	0.025%	1100.050	1099.830	0.020%
30	219.951	220.021	-0.032%	4.998	5.000	-0.040%	1099.680	1099.930	-0.023%
35	219.990	220.060	-0.032%	4.996	5.000	-0.088%	1099.290	1099.960	-0.061%
40	220.012	220.021	-0.004%	4.993	5.000	-0.142%	1098.910	1100.060	-0.105%
45	220.060	220.054	0.003%	4.991	5.000	-0.193%	1098.330	1099.840	-0.137%
50	220.054	220.053	0.000%	4.988	5.000	-0.256%	1097.580	1099.920	-0.213%
55	220.026	219.996	0.014%	4.983	5.000	-0.343%	1096.890	1099.910	-0.275%
60	220.050	220.027	0.010%	4.979	5.000	-0.427%	1095.800	1099.890	-0.372%
65	220.009	220.051	-0.019%	4.974	5.000	-0.522%	1094.700	1100.020	-0.484%
70	219.968	219.995	-0.012%	4.969	5.000	-0.630%	1093.210	1099.940	-0.612%
75	219.896	219.973	-0.035%	4.969	5.000	-0.629%	1093.060	1100.030	-0.634%
80	219.892	219.952	-0.027%	4.969	5.000	-0.637%	1092.600	1099.960	-0.669%
85	219.895	219.957	-0.028%	4.968	5.004	-0.704%	1092.840	1099.910	-0.643%



**Figure 6. Typical Accuracy versus Temperature**

**NOTE:** From the above graph, the error begins to go negative the higher temperature. This phenomenon is due to the board heating up and the combined temperature coefficient of the whole board is in effect.

## 7 Design Files

### 7.1 Schematics

To download the schematics, see the design files at [TIDM-SERVER-PWR-MON](#).

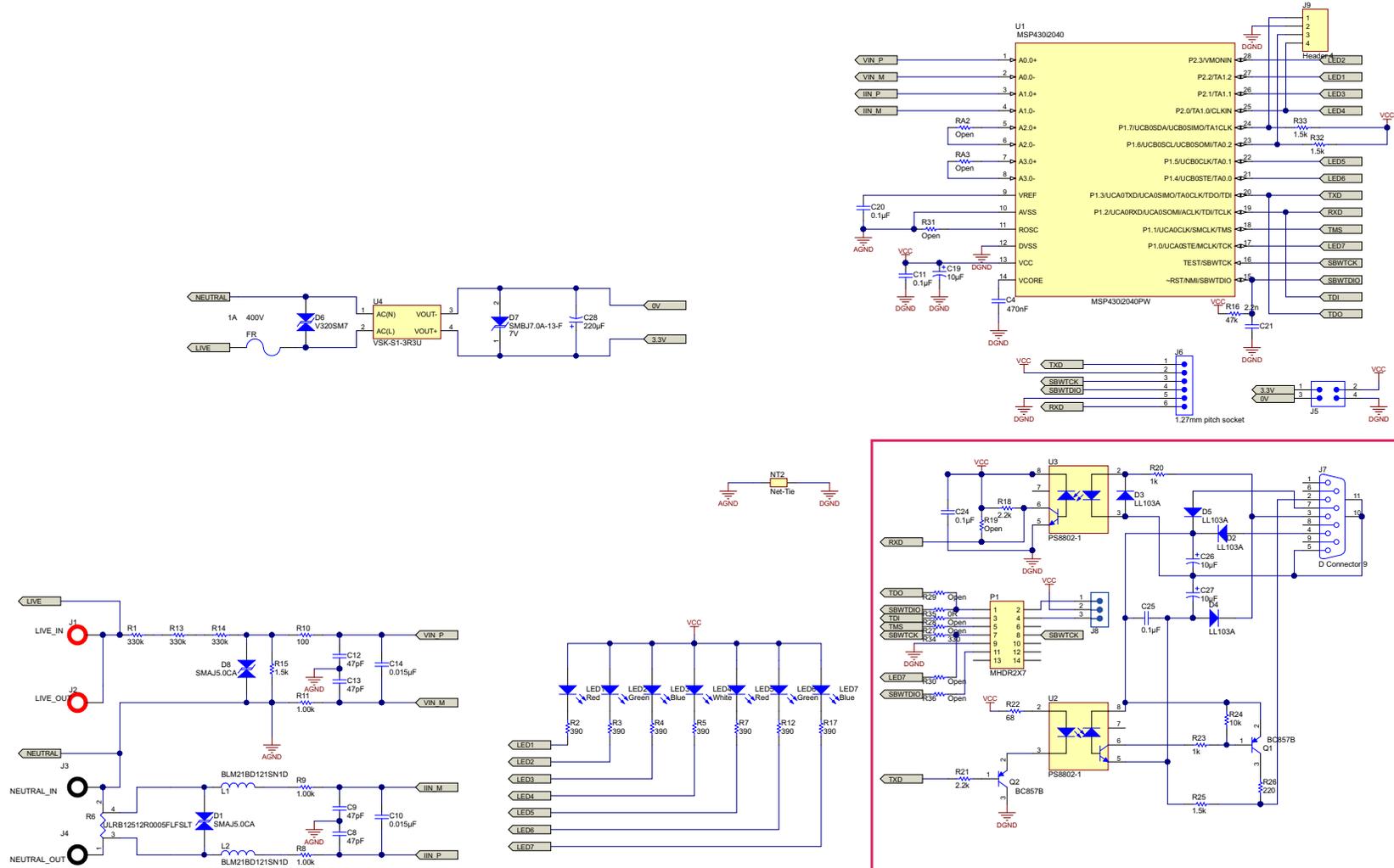


Figure 7. i2040 Sub-Meter EVM Schematics

## 7.2 Bill of Materials

To download the bill of materials (BOM), see the design files at [TIDM-SERVER-PWR-MON](#).

**Table 5. BOM**

ITEM	QTY	REFERENCE	VALUE	PART DESCRIPTION	MANUFACTURER	MANUFACTURER PARTNUMBER	PCB FOOTPRINT	NOTE
1	1	IPCB		Printed circuit board		Printed circuit board		
2	1	C4	470 nF	CAP, CERM, 470 nF	Taiyo Yuden	EMK107F474ZA-T	0603	<a href="#">Product Page Link</a>
3	1	R18	2.2 k	RES, 2.2 k $\Omega$ , x%, xW, [PackageReference],	Panasonic Electronic Components	ERJ-3GEYJ222V	0603	<a href="#">Product Page Link</a>
4	1	R19	Open	RES, open ohm, x%, xW, [PackageReference],			0603	Open
5	1	R20	1 k	RES, 1 k $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ102V	0603	<a href="#">Product Page Link</a>
6	1	R21	2.2 k	RES, 2.2 k $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ222V	0603	<a href="#">Product Page Link</a>
7	1	R22	68	RES, 68 $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ680V	0603	<a href="#">Product Page Link</a>
8	1	R23	1 k	RES, 1 k $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ102V	0603	<a href="#">Product Page Link</a>
9	1	R24	10 k	RES, 10 k $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ103V	0603	<a href="#">Product Page Link</a>
10	1	R25	1.5 k	RES, 1.5 k $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ152V	0603	<a href="#">Product Page Link</a>
11	1	R26	220	RES, 220 $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-3GEYJ221V	0603	<a href="#">Product Page Link</a>
12	4	C8, C9, C12, C13	47 pF	CAP, CERM, 47 pF, 50 V, $\pm$ 5%, C0G/NP0, 0402	Murata Electronics North America	GRM1555C1H470 JZ01	0402	<a href="#">Product Page Link</a>
13	2	C10, C14	0.015 $\mu$ F	CAP, CERM, 0.015 $\mu$ F, 50 V, $\pm$ 10%, X7R, 0402	Murata Electronics North America	GRM155R71H153 KA12D	0402	<a href="#">Product Page Link</a>
14	2	C11, C20	0.1 $\mu$ F	CAP, CERM, 0.1 $\mu$ F, 10 V, $\pm$ 10%, X5R, 0402	TDK Corporation	C1005X5R1A104K	0402	<a href="#">Product Page Link</a>
15	1	C19	10 $\mu$ F	CAP, TANT, 10 $\mu$ F, 10 V, $\pm$ 20%, 2.5 $\Omega$ , 3528-21 SMD	Vishay Sprague	293D106X0010B2 TE3	3528-21	<a href="#">Product Page Link</a>

Table 5. BOM (continued)

ITEM	QTY	REFERENCE	VALUE	PART DESCRIPTION	MANUFACTURER	MANUFACTURER PARTNUMBER	PCB FOOTPRINT	NOTE
16	1	C21	2.2 n	CAP, CERM, 2.2 nF, 25 V, ±10%, X7R, 0805	AVX Corporation	0805ZC222JAT2A	0805	<a href="#">Product Page Link</a>
17	2	C24, C25	0.1 µF	CAP, CERM, 0.1µF, 50V, +/-10%, X7R, 0603	TDK Corporation	C1608X7R1H104K	0603	<a href="#">Product Page Link</a>
18	2	C26, C27	10 µF	CAP, TANT, 10 µF, 50 V, ±10%, 0.8 Ω, 7343-43 SMD	AVX Corporation	F931D106KAA	7343-43	<a href="#">Product Page Link</a>
19	1	C28	220 µF	CAP, TANT, 220 µF, 6.3 V, ±10%, 0.6 Ω, 7343-31 SMD	AVX Corporation	TCJB227M006R0200	7343-31	<a href="#">Product Page Link</a>
20	2	D1, D8			Littelfuse Inc	SMAJ5.0CA	DSO-C2/X1.8	<a href="#">Product Page Link</a>
21	4	D2, D3, D4, D5			Vishay Semiconductor Diodes Division	LL103A	SOD-80	<a href="#">Product Page Link</a>
22	1	D6			Littelfuse Inc	V320SM7	V320SM7	<a href="#">Product Page Link</a>
23	1	D7	7 V	Diode, TVS, Uni, 7 V, 600 W, SMB	Diodes Incorporated	SMBJ7.0A-13-F	SMB	<a href="#">Product Page Link</a>
24	1	FR		Fuse, 1 A,125 V, SMD	Cooper Bussmann	6125FA1A	6125FA	<a href="#">Product Page Link</a>
25	4	H1, H2, H3, H4		Machine screw, round, #4-40 x 1/4, nylon, Philips panhead		NY PMS 440 0025 PH	NY PMS 440 0025 PH	Not populated
26	4	H5, H6, H7, H8		Standoff, Hex, 0.5"L #4-40 Nylon		1902C	Keystone_1902C	Not populated
27	1	J1				LIVE_IN	Hole for Banana Socket	N/A (3.5-mm diameter through hole only, no component populated)
28	1	J2				LIVE_OUT	Hole for Banana Socket	N/A (3.5-mm diameter through hole only, no component populated)
29	1	J3				NEUTRAL_IN	Hole for Banana Socket	N/A (3.5-mm diameter through hole only, no component populated)
30	1	J4				NEUTRAL_OUT	Hole for Banana Socket	N/A (3.5-mm diameter through hole only, no component populated)
31	1	J5		Header, TH, 100 mil, 2x2, gold plated, 230 mil above insulator	TE Connectivity	TSW-102-07-G-D	TSW-102-07-G-D	<a href="#">Product Page Link</a>

**Table 5. BOM (continued)**

ITEM	QTY	REFERENCE	VALUE	PART DESCRIPTION	MANUFACTURER	MANUFACTURER PARTNUMBER	PCB FOOTPRINT	NOTE
32	1	J6			Sullins Connector Solutions	1.27mm pitch socket	6-pin header (1.27mm)	<a href="#">Product Page Link</a>
33	1	J7		Receptacle assembly, 9 position, right angle	TE Connectivity	D Connector 9	DSUB1.385-2H9	<a href="#">Product Page Link</a>
34	1	J8	1 x 3	Header, TH, 100 mil, 1x3, gold plated, 230 mil above insulator	Sullins Connector Solutions	PBC03SAAN	PBC03SAAN	<a href="#">Product Page Link</a>
35	1	J9		Header, 4-Pin 100 mil 1x4	TE Connectivity	Header 4	A31114-ND	<a href="#">Product Page Link</a>
36	2	L1, L2		Inductor, [Technology], [Material], xxuH, xxA, x.xx ohm, [MountType]	Murata Electronics North America	BLM21BD121SN1 D	0805	<a href="#">Product Page Link</a>
37	1	LBL1		Thermal transfer printable labels, 0.650" W x 0.200" H - 10,000 per roll		Size: 0.65" x 0.20 "	Label_650x200	Not populated
38	2	LED1, LED5		Red	Lite-On Inc	LTST-C170KRKT	0805-LED	<a href="#">Product Page Link</a>
39	2	LED2, LED6		Green	Lite-On Inc	LTST-S220KGKT	0805-LED	<a href="#">Product Page Link</a>
40	2	LED3, LED7		Blue	Lite-On Inc	LTST-C170TBKT	0805-LED	<a href="#">Product Page Link</a>
41	1	LED4		White	Lite-On Inc	LTW-170TK	0805-LED	<a href="#">Product Page Link</a>
42	1	P1		Header, 7-pin, dual row	TE Connectivity	A104860-ND	2X7BOXHEADER	<a href="#">Product Page Link</a>
43	2	Q1, Q2	0.075 V	Transistor, PNP, 45 V, 0.1 A, SOT-23	Micro Commercial Co	BC857B	SOT-23	<a href="#">Product Page Link</a>
44	3	R1, R13, R14	330 k	RES, 330 kΩ, 1%, 1 W, 2010, RES, 330 kΩ, 5%, 1 W, 2010	Panasonic Electronic Components	ERJ-S1DF3303U	2010M	<a href="#">Product Page Link</a>
45	1	R15	1.5 k	RES, 1.5 kΩ, 1%, 1 W, 2010, RES, 330 kΩ, 5%, 1W, 2010	Rohm Semiconductor	MCR50JZHF1501	2010M	<a href="#">Product Page Link</a>
46	7	R2, R3, R4, R5, R7, R12, R17	390	RES, 390 Ω, 5%, 0.125 W, 0805	Panasonic Electronic Components	ERJ-6GEYJ391V	0805	<a href="#">Product Page Link</a>
47	1	R6	500 μΩ	Shunt resistor	International Resistive	ULRB12512R0005 FLFSLT	Current Sensing Pad	<a href="#">Product Page Link</a>
48	3	R8, R9, R11	1.00 k	RES, 1.00 kΩ, 1%, 0.063 W, 0402	Vishay Dale	CRCW04021K00F KED	0402	<a href="#">Product Page Link</a>
49	1	R10	100	RES, 100 Ω, 1%, 0.063 W, 0402	Vishay Dale	CRCW0402100RF KED	0402	<a href="#">Product Page Link</a>
50	1	R16	47 k	RES, 47 kΩ, 5%, 0.063 W, 0402	Vishay Dale	CRCW04024K70J NED	0402	<a href="#">Product Page Link</a>
51	7	R27, R28, R29, R30, R31, R36, RA3	Open	RES, open Ω, x%,		Open	0805	Open
52	1	R32	1.5 k	RES, 1.5 kΩ, x%,	Panasonic Electronic Components	ERJ-6GEYJ152V	0805	<a href="#">Product Page Link</a>

**Table 5. BOM (continued)**

ITEM	QTY	REFERENCE	VALUE	PART DESCRIPTION	MANUFACTURER	MANUFACTURER PARTNUMBER	PCB FOOTPRINT	NOTE
53	1	R33	1.5 k	RES, 1.5 k $\Omega$ , x%,	Panasonic Electronic Components	ERJ-6GEYJ152V	0805	<a href="#">Product Page Link</a>
54	1	R35	0 R	RES, 0 $\Omega$ , x%	Panasonic Electronic Components	ERJ-6GEY0R00V	0805	<a href="#">Product Page Link</a>
55	1	R34	330	RES, 330 $\Omega$ , x%, xW, [PackageReference]	Panasonic Electronic Components	ERJ-6GEYJ331V	0402	<a href="#">Product Page Link</a>
56	1	U1		MSP430i2040	Texas Instruments	MSP430i2040PW	TSSO10x6-G28	
57	2	U2, U3		PS8802-1	CEL	PS8802-1	SO-8	<a href="#">Product Page Link</a>
58	1	U4		Onboard block power supply	CUI Inc	VSK-S1-3R3U	VSK-S1	<a href="#">Product Page Link</a>

### 7.3 PCB Layout

To download the layer plots, see the design files at [TIDM-SERVER-PWR-MON](#).

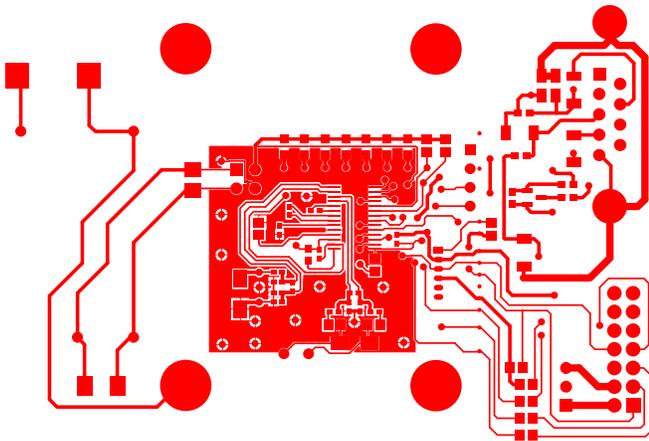


Figure 8. Top Layer

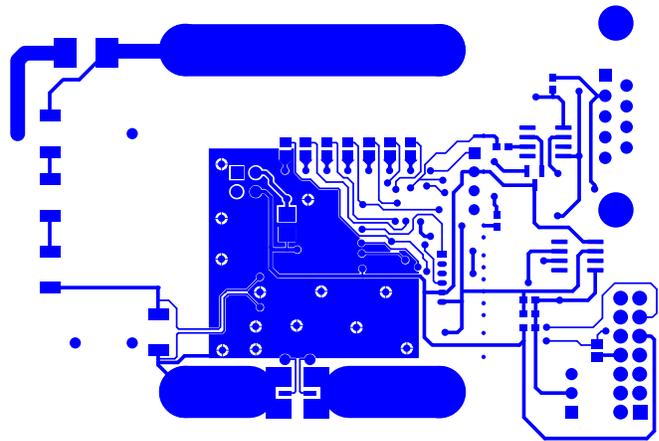


Figure 9. Bottom Layer

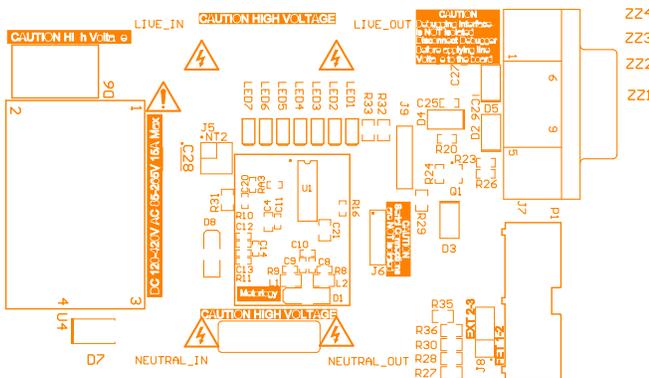


Figure 10. Top Overlay

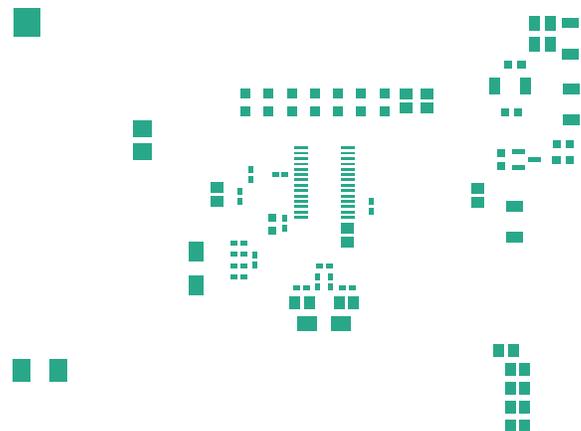


Figure 11. Top Solder Paste

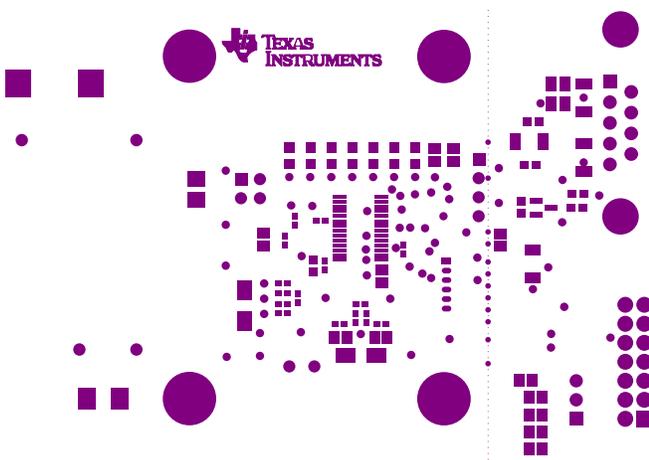


Figure 12. Top Solder Mask

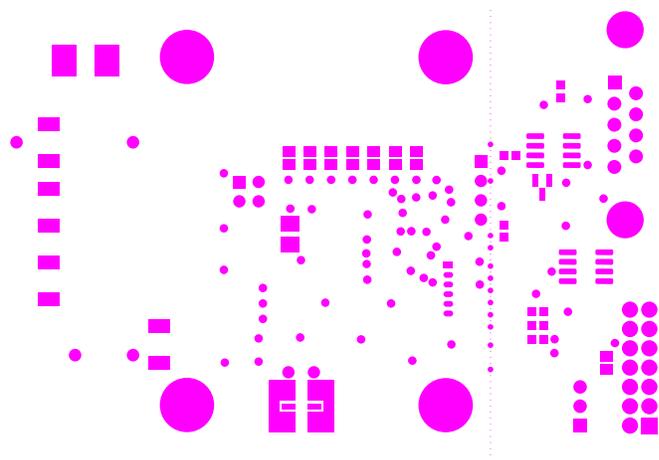


Figure 13. Bottom Solder Mask

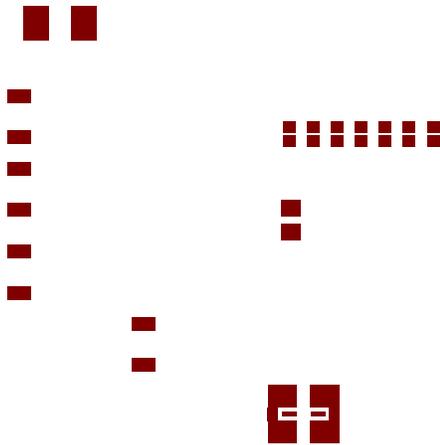


Figure 14. Bottom Solder Paste

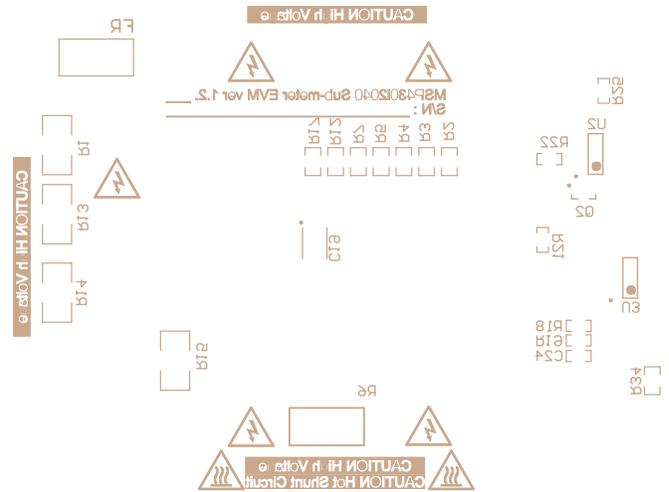


Figure 15. Bottom Overlay



Figure 16. Board Outline

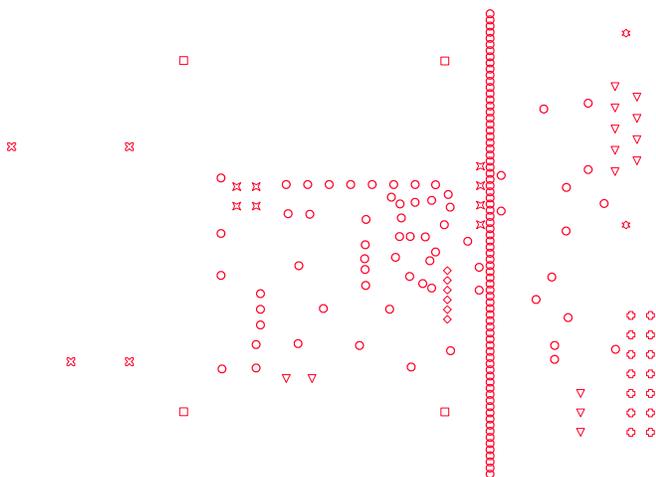


Figure 17. Drill Drawing

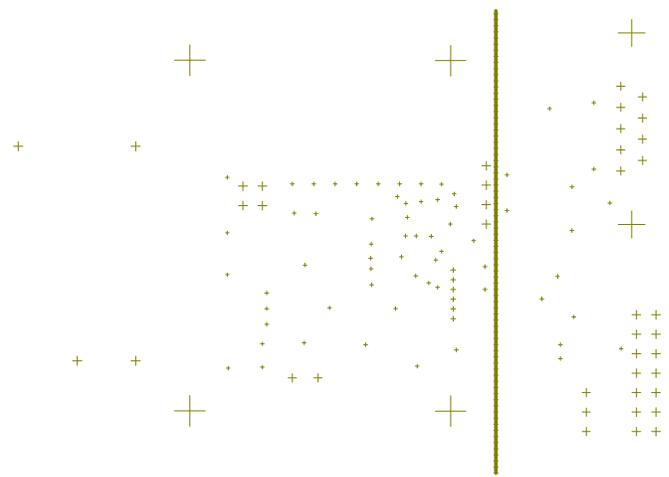


Figure 18. Drill Guide

### 7.4 Altium Project

To download the Altium project files, see the design files at [TIDM-SERVER-PWR-MON](#).

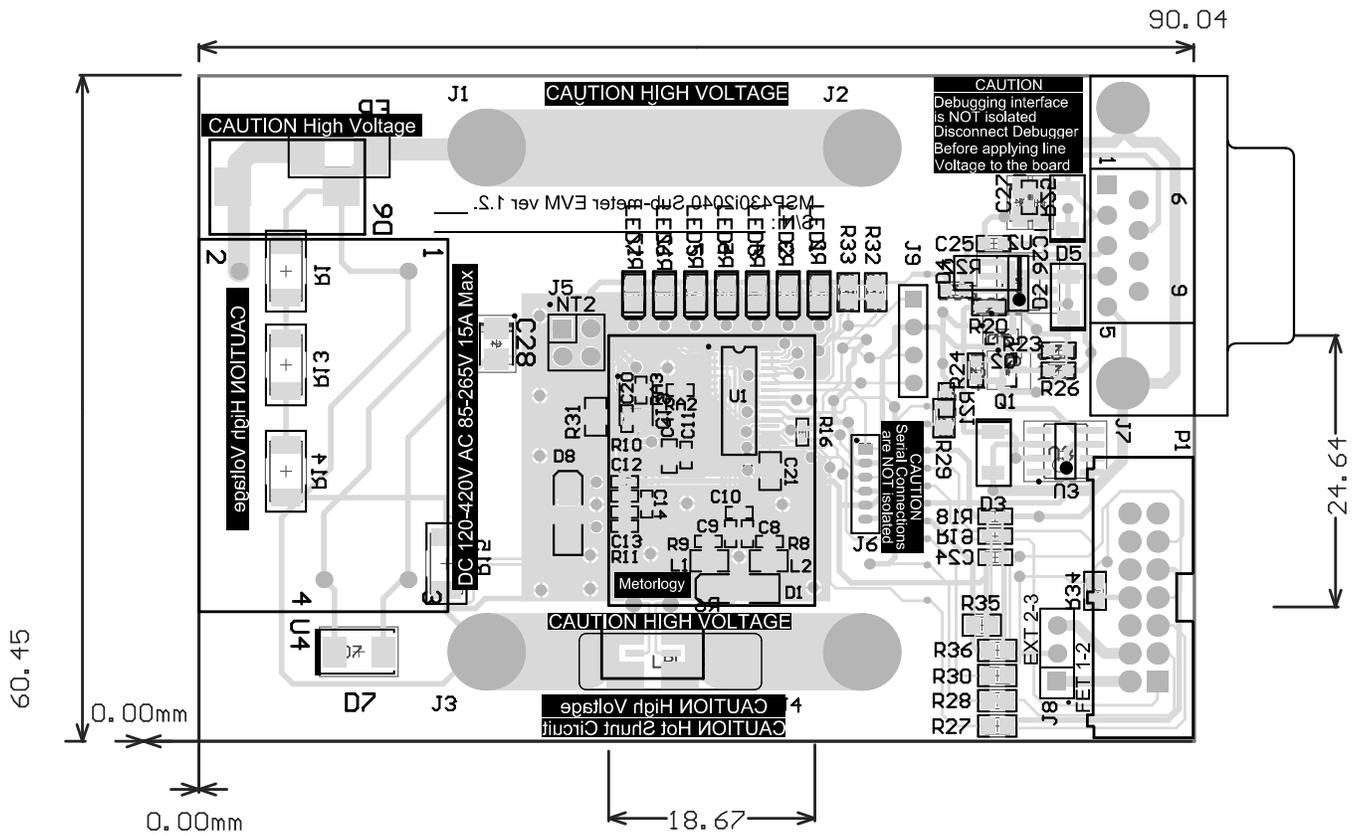


Figure 19. Altium Project Image 1

### 7.5 Gerber Files

To download the Gerber files, see the design files at [TIDM-SERVER-PWR-MON](#)

## 7.6 Assembly Drawings

To download the assembly files, see the design files at [TIDM-SERVER-PWR-MON](#).

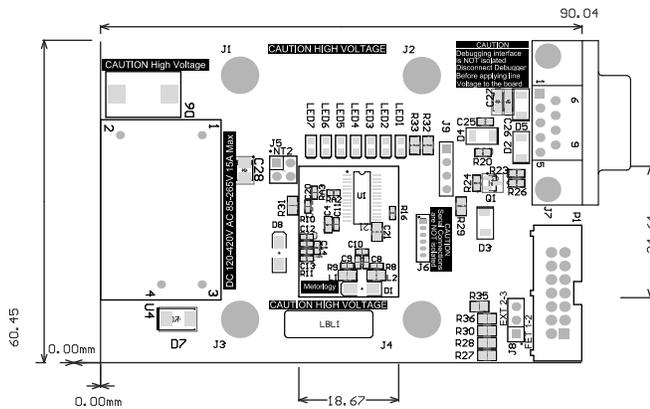


Figure 20. Assembly Drawing Layer 1

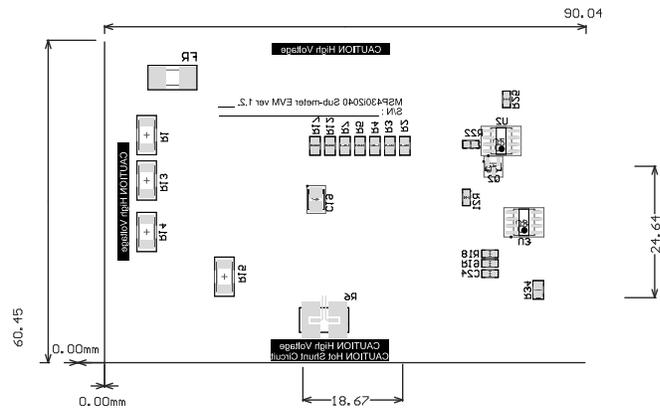


Figure 21. Assembly Drawing Layer 2

## 7.7 Software Files

To download the software files, see the design files at [TIDM-SERVER-PWR-MON](#).

## 8 References

1. KP-P3001-C AC Meter Test Set ([link](#))
2. HC 3100 Reference Meter ([link](#))
3. Chroma 61500 Series LOW POWER Programmable AC Source ([link](#))
4. Chroma 66201 and 66202 Reference Meter ([link](#))
5. Chroma 6310/A Series Modular DC Electronic Load ([link](#))

## 9 About the Author

**MARS LEUNG** received his bachelor of engineering in Hong Kong Polytechnic University and his master of science at the Chinese University of Hong Kong. He has been field application engineer specialized in MCU application support and development; senior smartcard application engineer specialized in smart card payment system definition and implementation; staff engineer specialized in MCU and new module definition; staff engineer in analog system application specialized in digital system; and video processing of dynamic LED backlight control. He is now staff engineer in Texas Instruments' smart grid application team specialized in embedded electricity metering application.

## Appendix A Example Application Code

### A.1 Introduction

Project structure:

- emeter-communication.c – source code for low level UART communication routines including UART port setup, write and read from UART, interrupt services routine for byte-wise send and receive
- emeter-dlt645.c – source code for the polling mode protocol implementation
- emeter-main.c – source code for system initialization, main loop, callback functions implementation and interrupt vector placement
- emeter-metrology-i2041.r43 – embedded metering library object code
- emeter-setup.c – source code for low level system initialization
- emeter-template.h – source code for configuration
- metrology-calibration-default.c – source code to put the user defined default calibration parameter into a proper data structure (should not modify this file)
- metrology-calibration-template.h – source code of user defined default calibration parameter
- emeter-autoreport.c – source code for performing auto reporting.

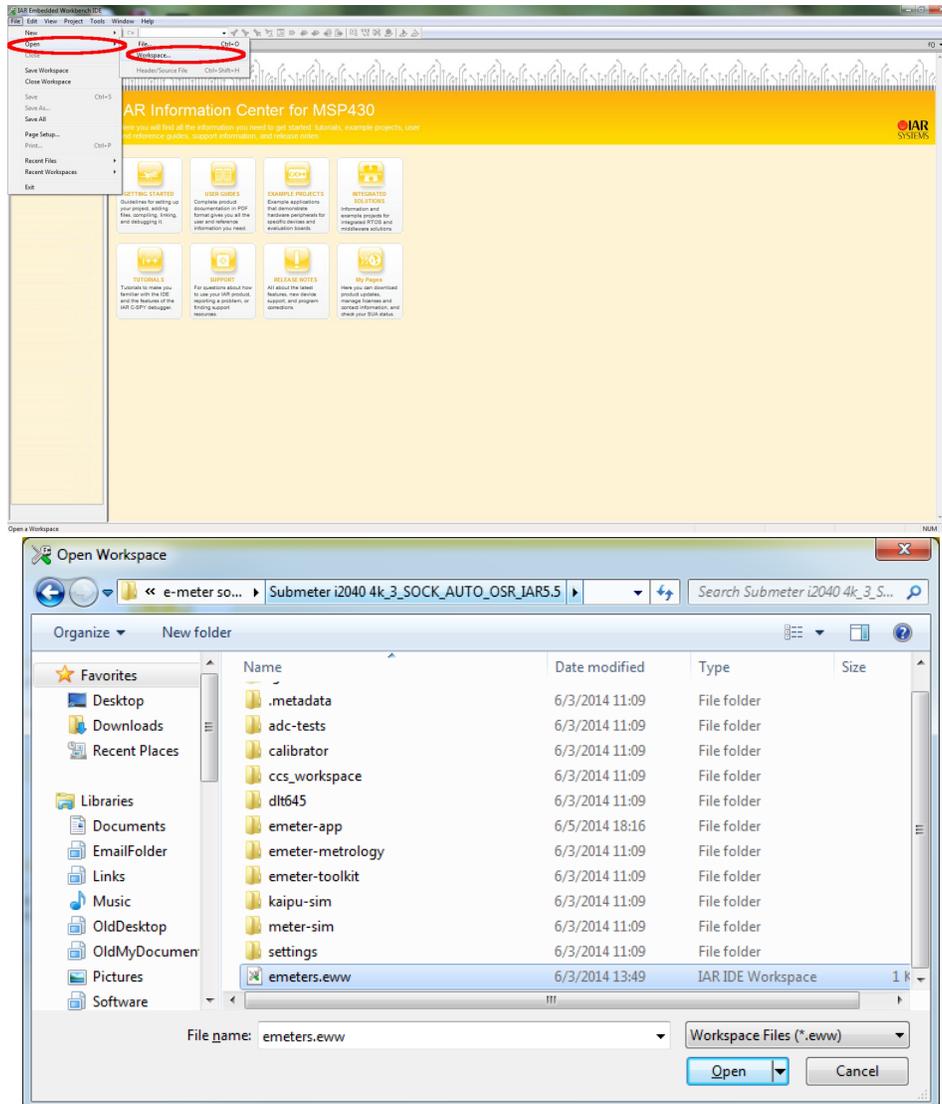
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**NOTE:** To enable auto report support uncomment the `#define AUTOREPORT_SUPPORT` definition in `emeter-template.h`.

---

## A.2 Preparing the Application Code to Run

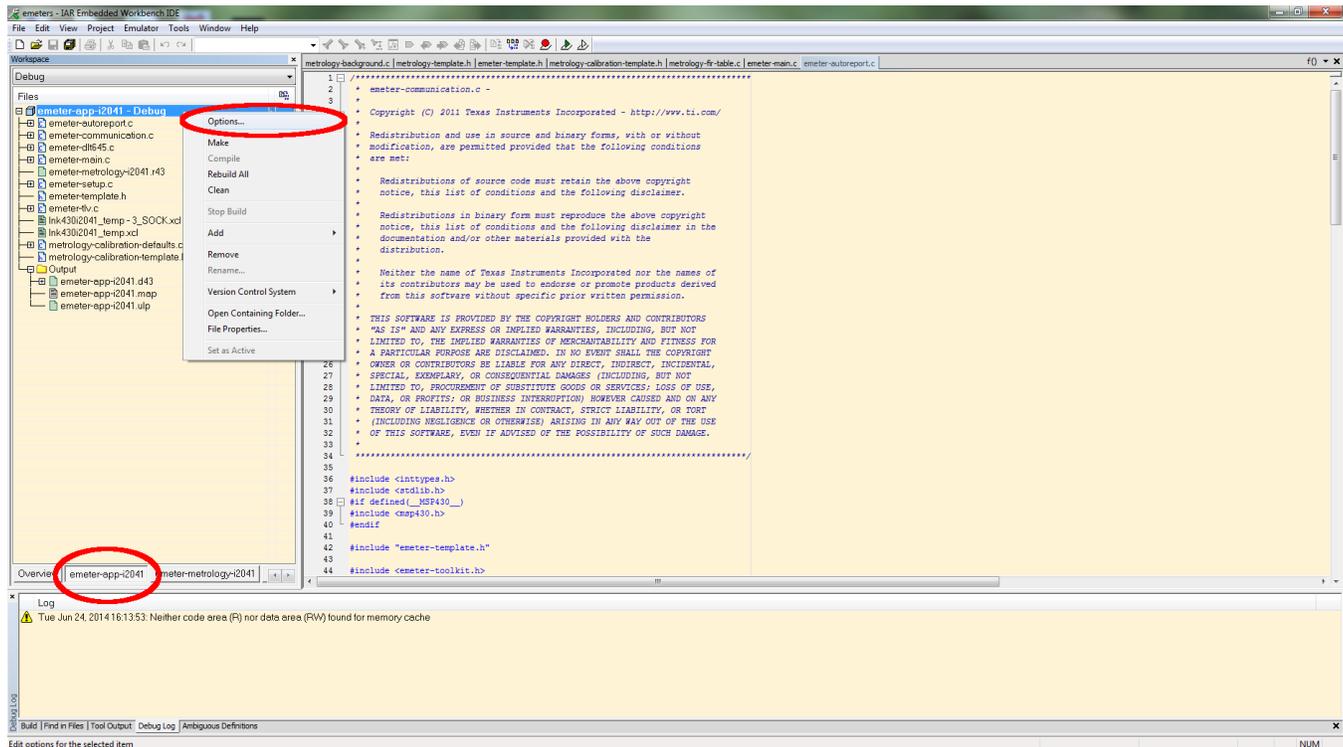
1. Launch the IAR5.5 Embedded Workbench IDE and click on *File*→*Open*→*Workspace*.
2. Select “emeters.eww” when prompted to open *Workspace*.



**Figure 22. Opening Workspace**

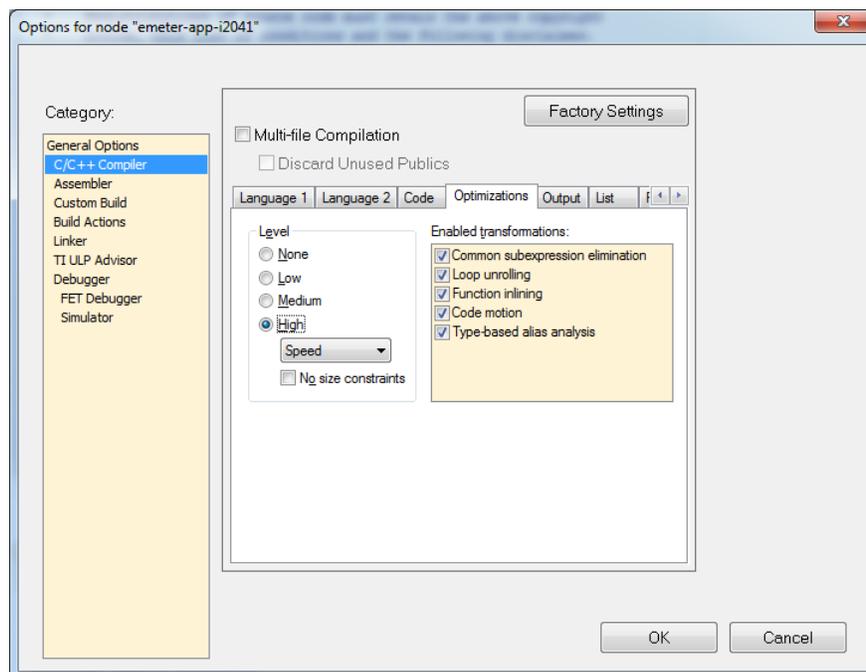
3. Select the *emeter-app-i2041* project tab at the bottom of the *Workspace* window.

4. Check project options by right clicking the project name and select *Options...* from the pop-up menu (see [Figure 23](#)).



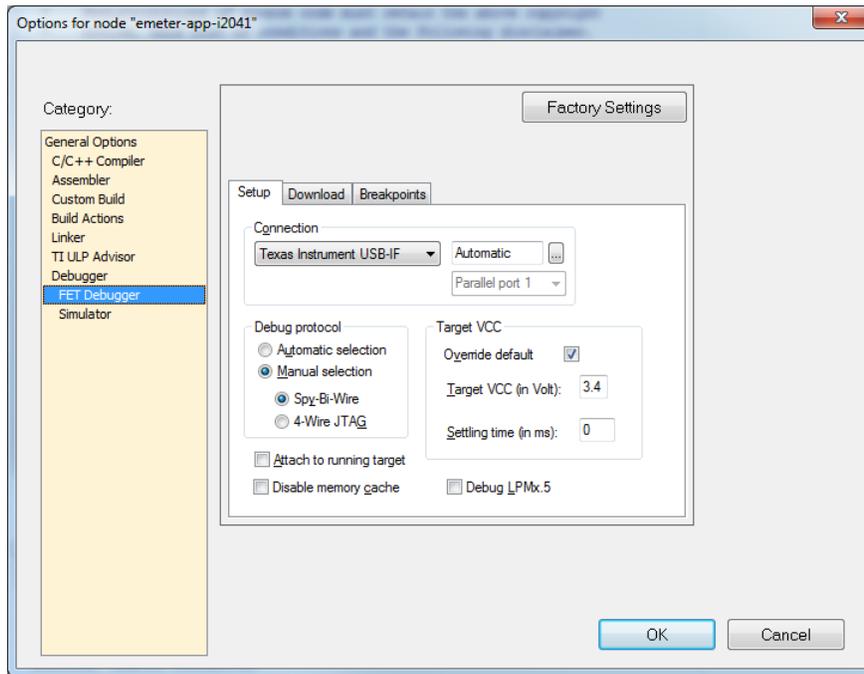
**Figure 23. Project Tab**

5. When the options appear, select *C/C++ Compiler* on the left-hand column. Then select the *Optimizations* tab on the right-hand side and check the optimization settings as shown in [Figure 24](#).



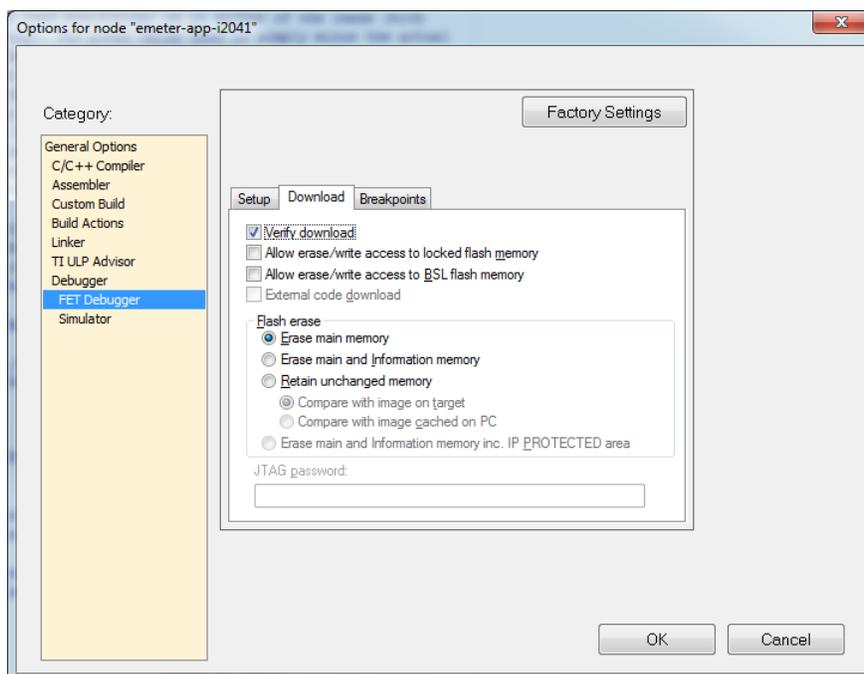
**Figure 24. Optimization Options**

6. Select *FET Debugger* on the left-hand column, then select the *Setup* tab. The EVM uses *Spy-Bi-Wire* for its code downloading and debugging. Check to make sure the options are as shown in [Figure 25](#).



**Figure 25. Debugger Options**

7. Select the *Download* tab. Under *Flash erase*, do not choose *Erase main memory and Information memory*, this option erases both sets of data and cannot be recovered. Instead, choose *Erase main memory* as the download option to preserve these factory parameters: system clock calibration, ADC calibration, and internal reference calibration (see [Figure 26](#)). However, metrology calibration stored in the main memory, such as VGAIN, IGAIN, PGAIN, and so on, are always erased after downloading.



**Figure 26. Download Options**

8. Click *OK* after all of the changes are made.

- Rebuild the project by right-clicking on the project and select *Rebuild All* from the pop-up menu (see [Figure 27](#)). Three warnings will be reported during rebuilding (see [Figure 28](#)), which are safe to ignore. To open the project workspace and modify, compile, and download the code, the user must have IAR Embedded Workbench 5.5 installed with a valid license. If a valid license is not available, the user can still download the object code. See [Section A.3](#) for downloading procedures.

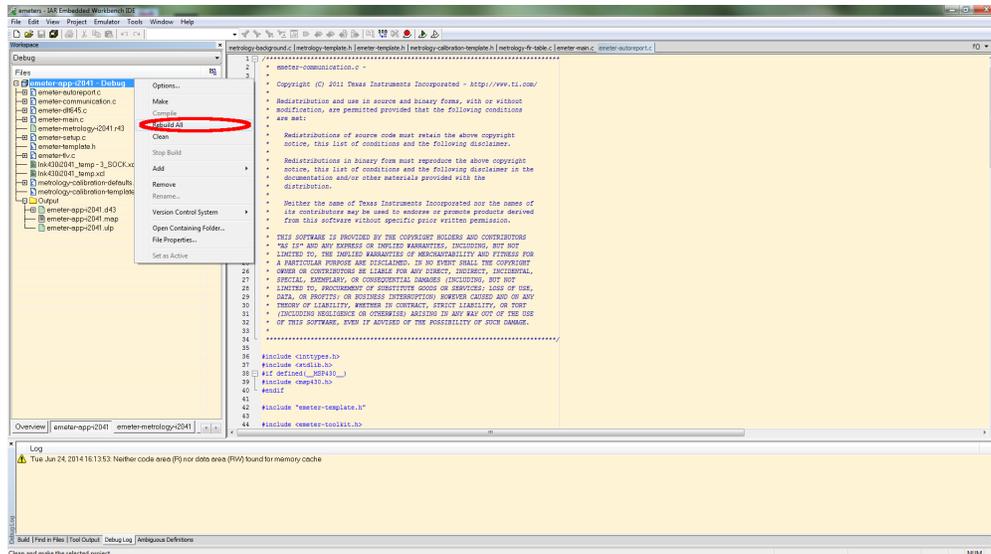


Figure 27. Compiling the Application

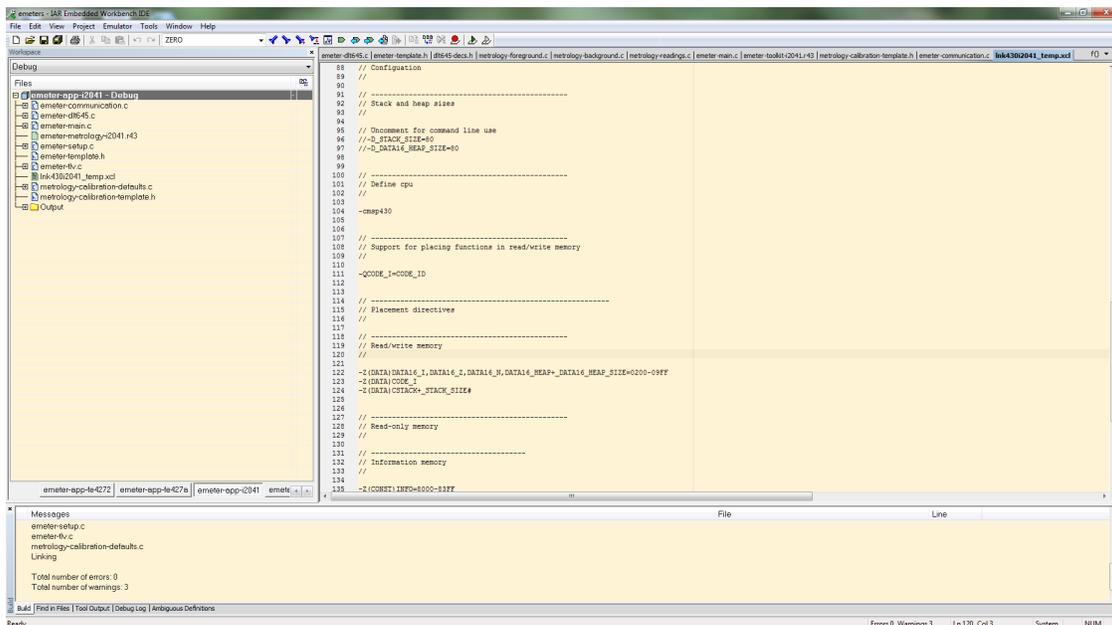


Figure 28. Warnings

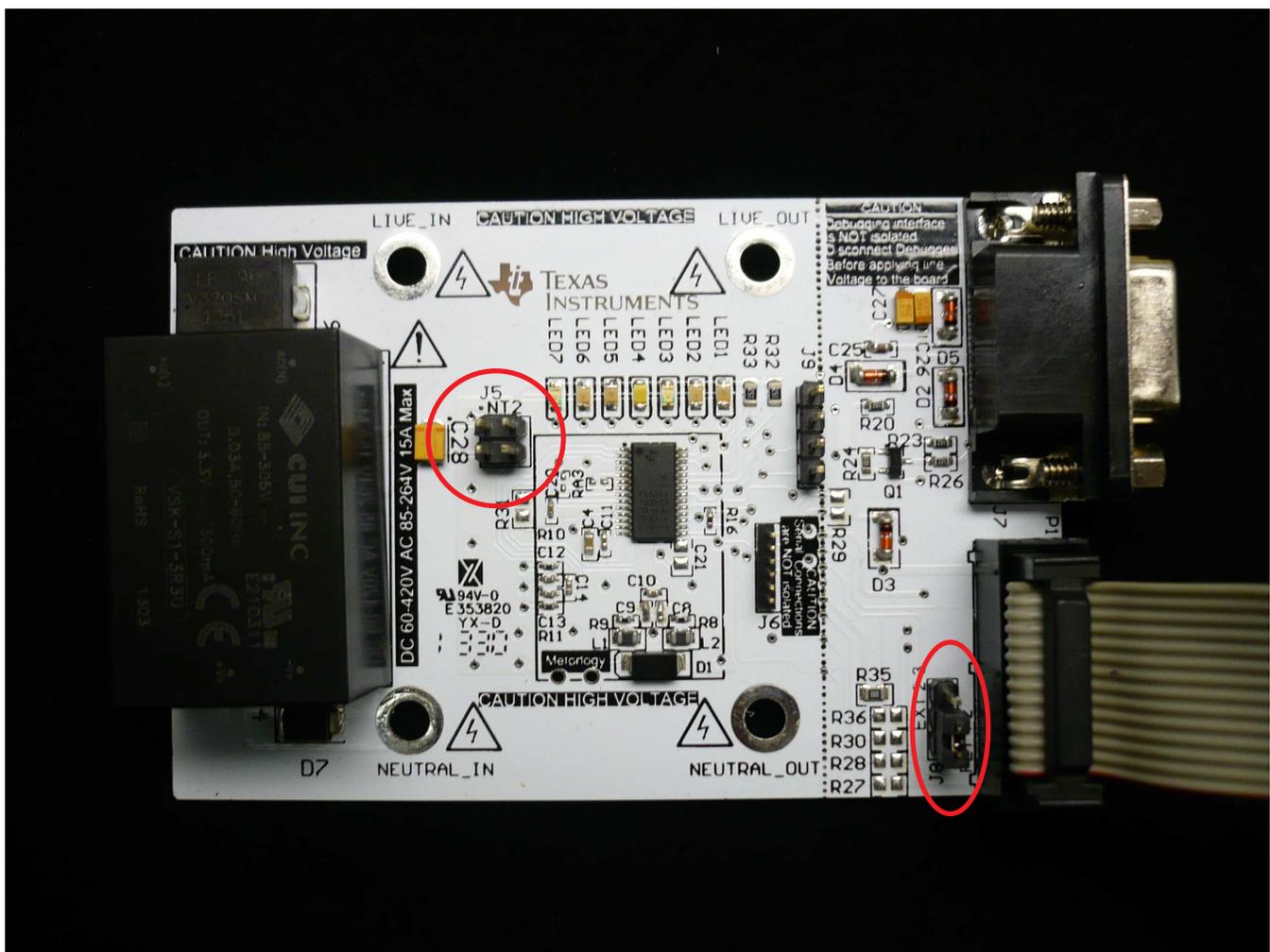
- Make sure the jumper on J8 is short properly. Connect the 14-pin connector P1 to MSP-FET430UIF by a flat cable as shown in [Figure 29](#).



**CAUTION**

The debugging interface is not isolated. Make sure to properly isolate between the EVM and the PC used for debugging with AC or DC high voltage connected.

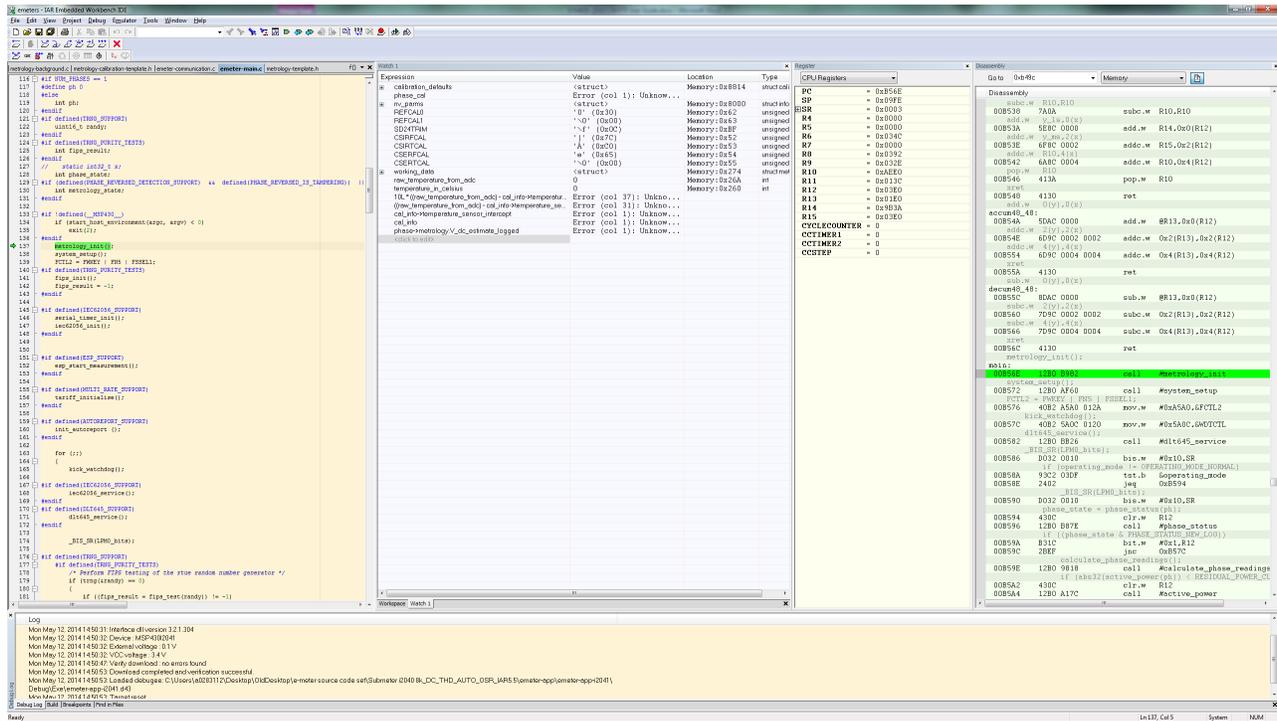
**NOTE:** Connection to debugging interface is optional for the operation of the EVM. The EVM can operate without a debugger connected.



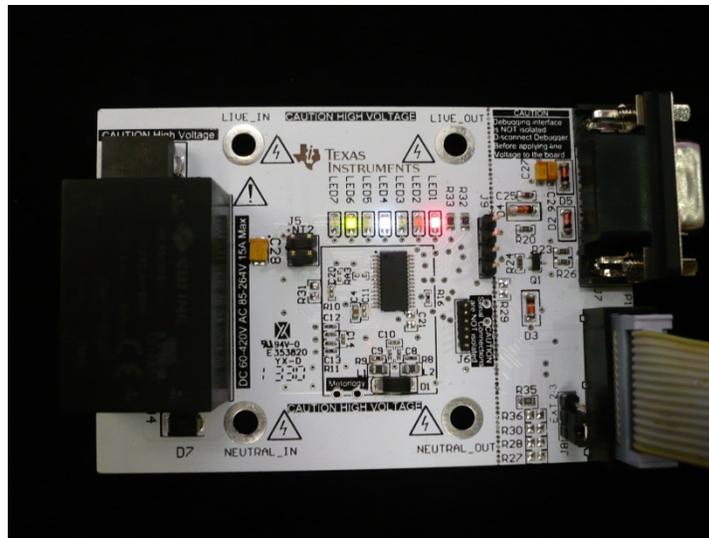
**Figure 29. Connecting EVM and FET**



12. After successfully completing the download, **Figure 31** appears. Click Go to run the application.



**Figure 31. Debugger Screen**



**Figure 32. EVM Running**

### A.3 Downloading without an IAR License

If a valid IAR Embedded Workbench 5.5 license is not available, download the executable code to the board with the following steps using the installed IAR Embedded Workbench 5.5.

1. Open the project workspace as described in [Section A.2, Steps 1 through 7](#). Then connect the board to the MSP-FET430UIF as described in [Step 10](#) in [Section A.2](#).
2. Select *Project*→*Download*→*Download File...* from the menu (see [Figure 33](#)).
3. When prompted to select a file, go to the folder [Submeter i2040 8k\_DC\_THD\_AUTO\_OSR\_IAR5.5]emeter-app\emeter-app-i2041\Debug\Exe and select the file named “emeter-app-i2041.d43” ([Figure 34](#)).

The executable code will then download to the board.

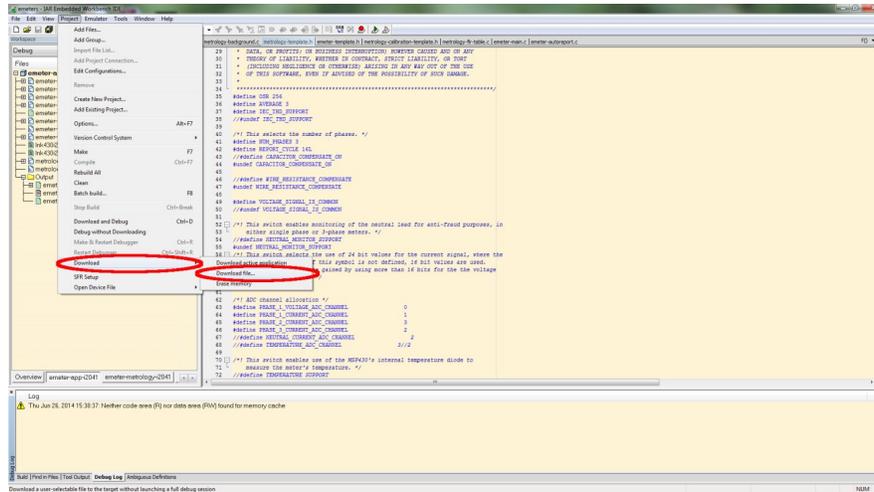


Figure 33. Download Executable File

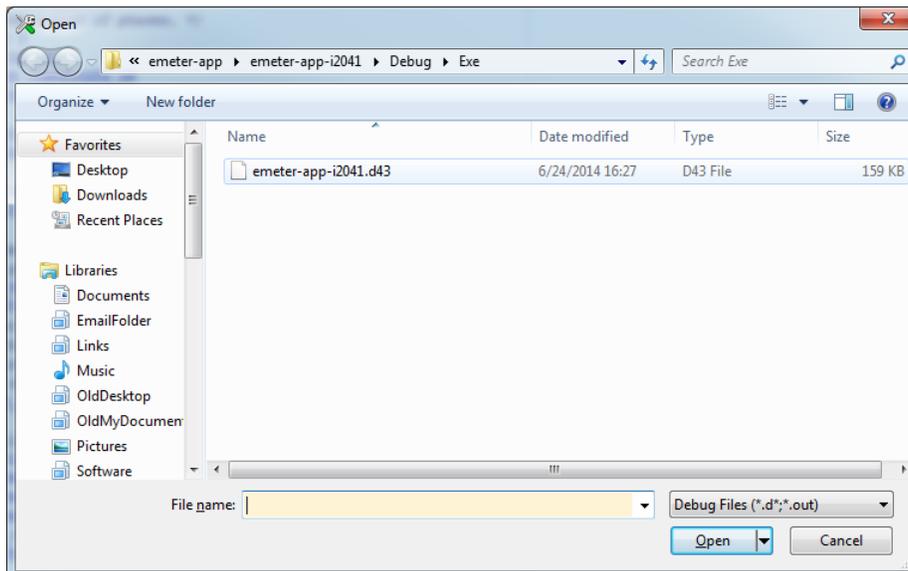


Figure 34. Select File to Download

## Appendix B EVM Operation

### B.1 Download Application Code

Download application to the board by using the IAR compiler as described in [Appendix A](#).

### B.2 Setting up the PC Software Tool

Unzip the file named "calibrator-runtime.zip" into any folder. A folder named "calibrator-runtime" containing the necessary files to run the software tool will be in that folder. The file named "calibrator-20121120.exe" is the executable file of the software tool. The file named "calibrator-config.xml" contains the setup information for the software tool. Users must make a few edits to this XML file before calibrator-20121120.exe can launch.

Follow these steps to setup the XML to run calibrator-20121120.exe properly:

1. Right click the *My Computer* icon and select *Properties* in the pop-up menu.
2. Select the *Hardware* tab in the *System Properties* window, then click on the *Device Manager* to go to its window.

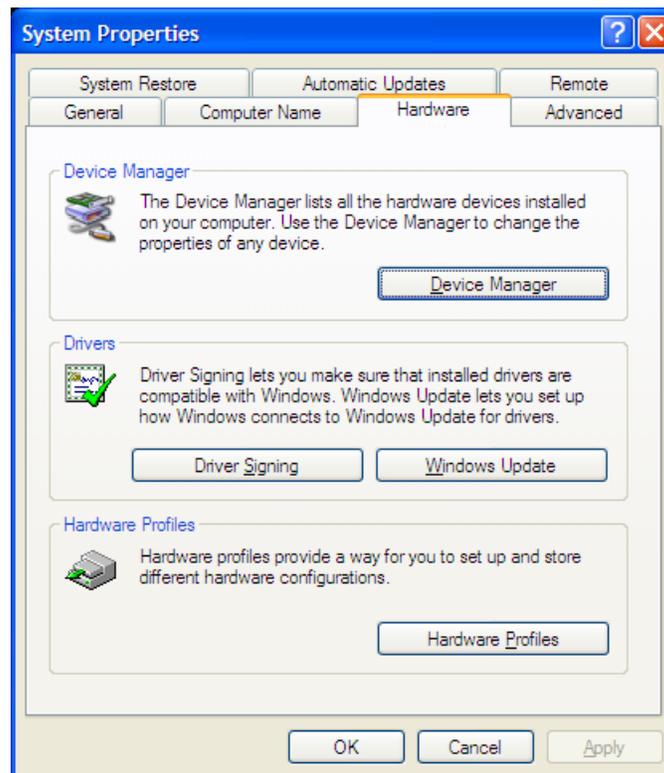
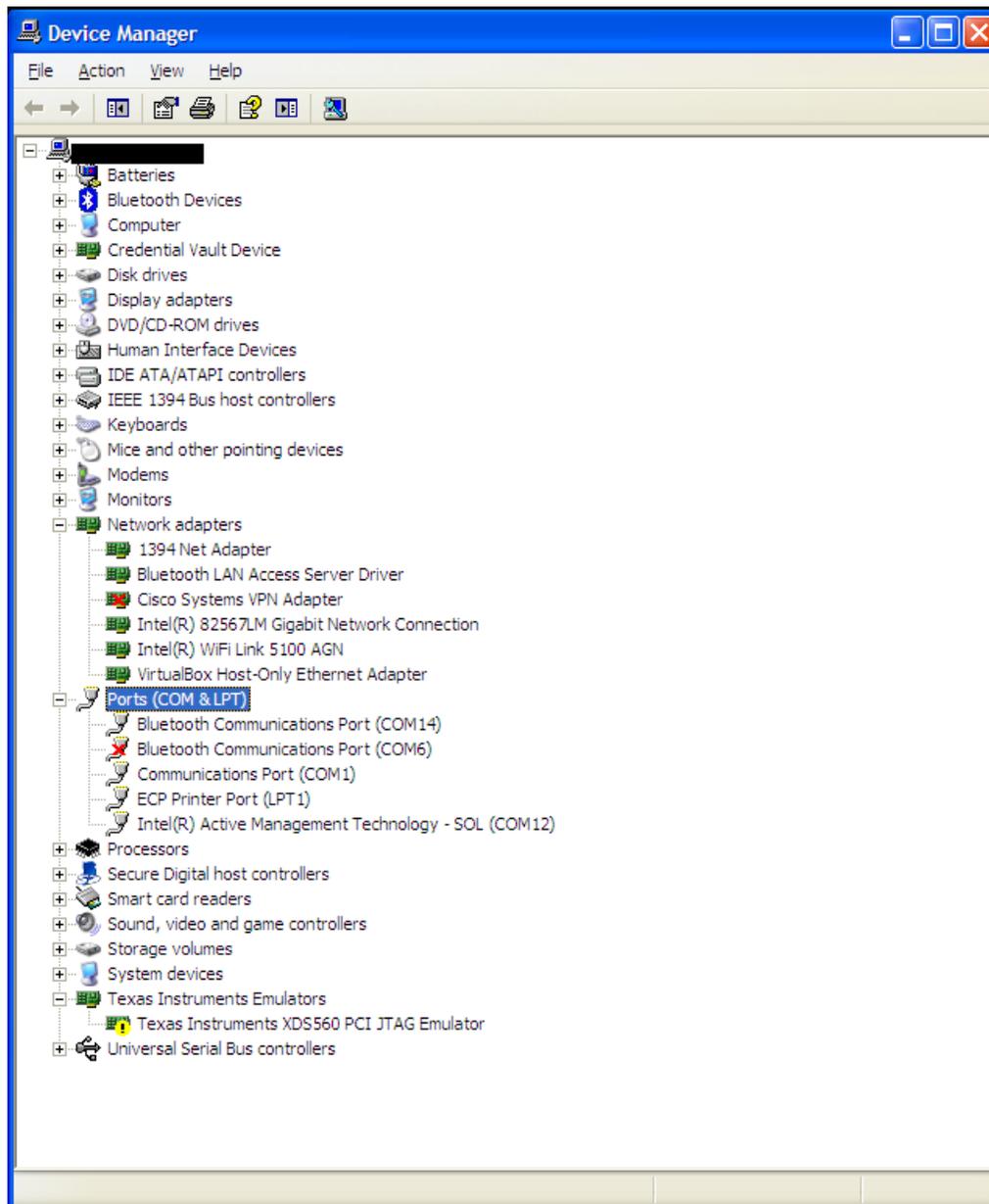


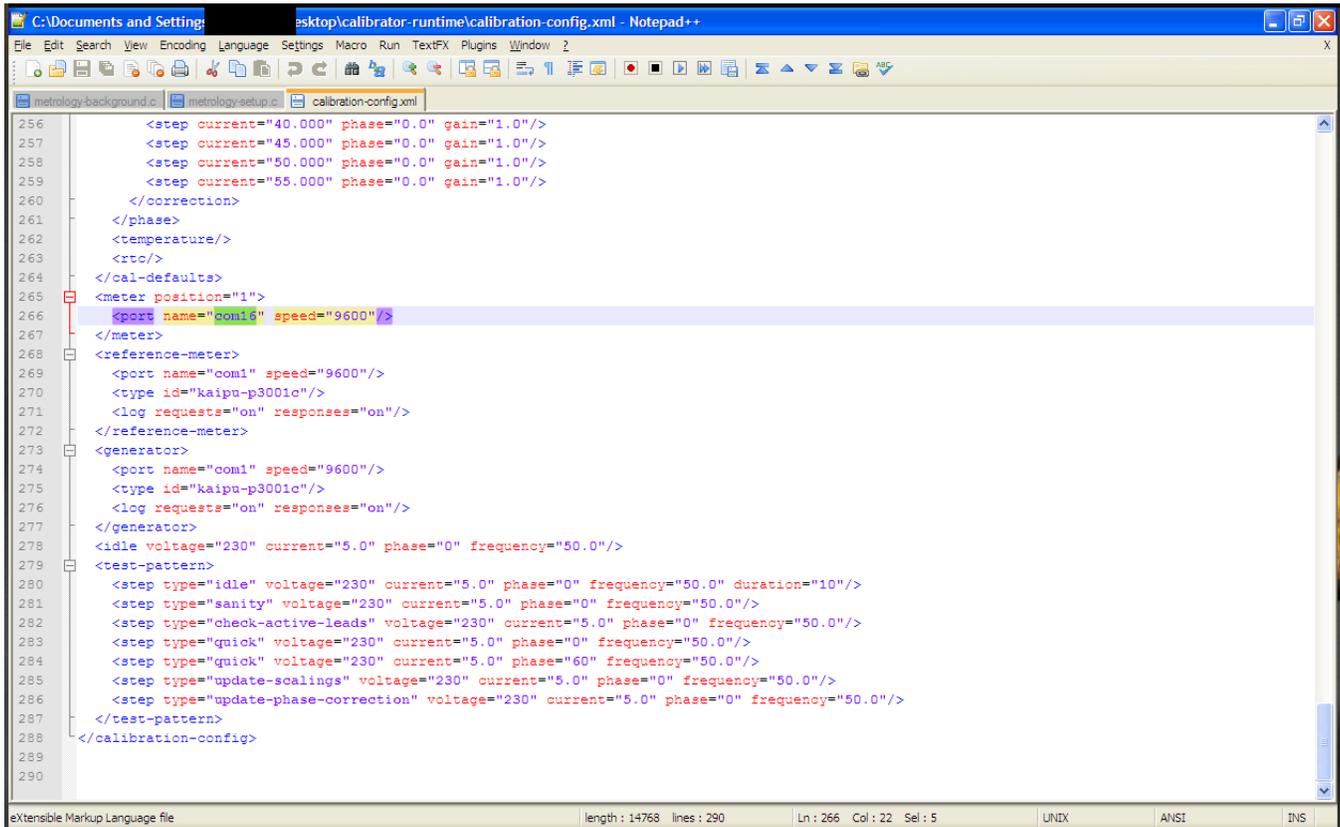
Figure 35. System Properties Window

3. Check the COM port number of the serial port that connects the PC and the EVM.



**Figure 36. Device Manager Window**

4. Open “calibration-config.xml” in the folder “calibrator-runtime” with a text or XML editor. Go to the line highlighted in [Figure 37](#), put in the COM port number in, and save the file.



**Figure 37. Editing “calibration-config.xml”**

### B.3 Setup the EVM Hardware



#### CAUTION

Do not supply power to the EVM until the hardware and software setup is completed.

1. Install jumpers to J5 as shown in [Figure 38](#).
2. Connect AC/DC source to LIVE\_IN and NEUTRAL\_IN. Connect test load to LIVE\_OUT and NEUTRAL\_OUT.
3. Connect the serial connector to the PC serial port with a serial cable.
4. Apply AC/DC source power.

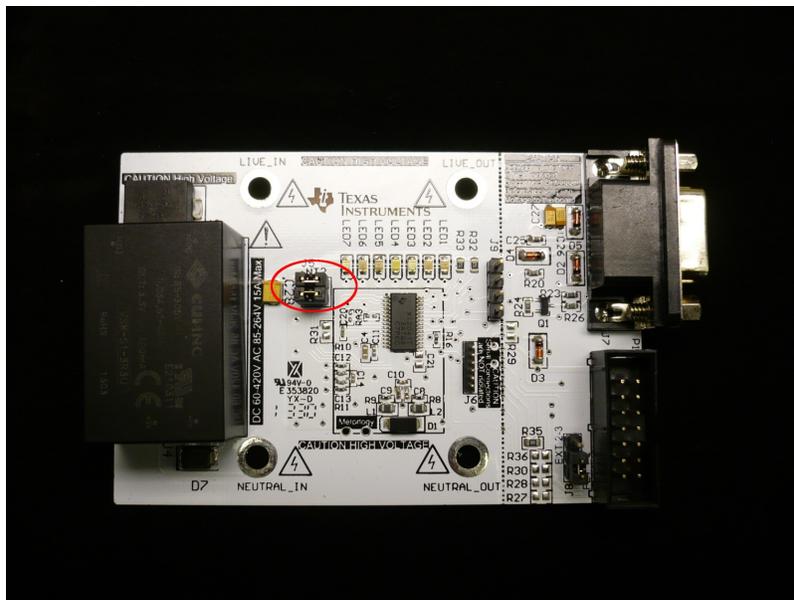


Figure 38. Jumpers

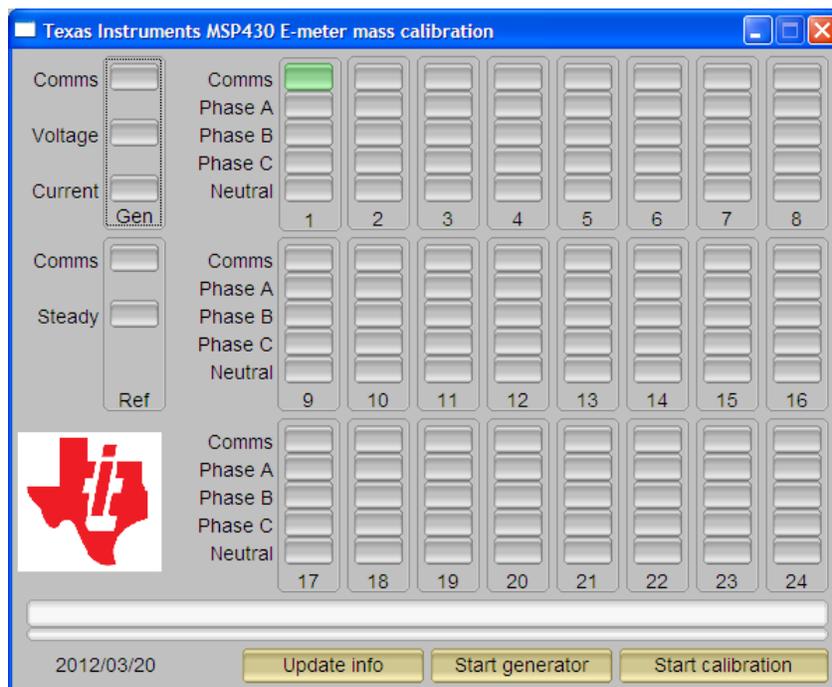
### B.4 Start Using the EVM

When the EVM has been powered, some of the LEDs will flash or turn on to indicate its operation status while the other LEDs are not used. The user can change the provided source code to make use of all seven LEDs as needed. [Table 6](#) lists how each LED is used.

**Table 6. LED Status**

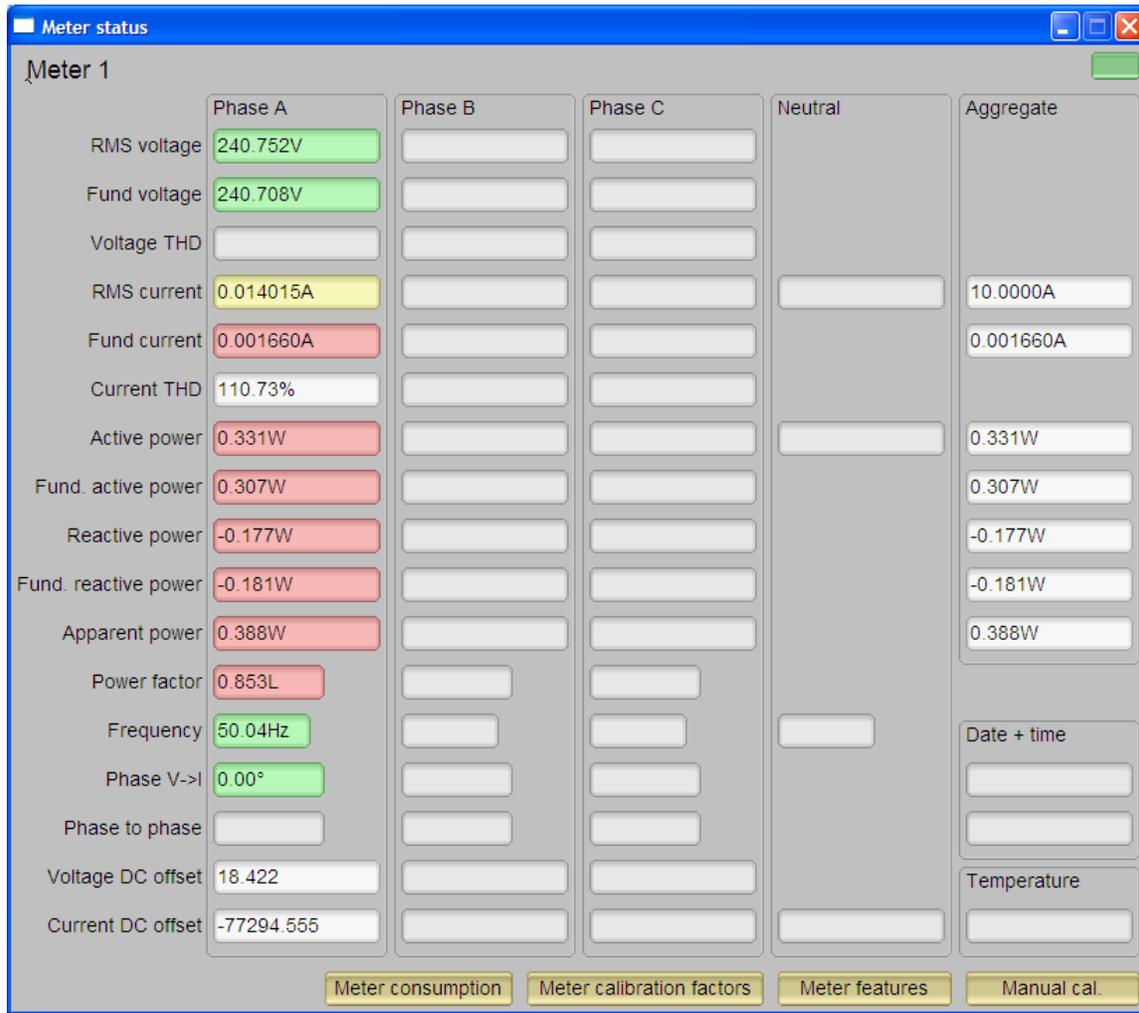
LED	STATE	INDICATION
LED1	ON	Background operations running
LED1	OFF	Background operations completed
LED2	ON	Negative voltage half cycle
LED2	OFF	Positive voltage half cycle
LED3	ON	Not used
LED3	OFF	Not used
LED4	ON	Foreground operations running
LED4	OFF	Foreground operations completed
LED5	ON	EVM is in AC mode measurement
LED5	OFF	EVM is not in AC mode measurement
LED6	ON	EVM is in DC mode measurement
LED6	OFF	EVM is not in DC mode measurement
LED7	ON	Active energy pulse pulsing
LED7	OFF	Active energy pulse idle

To run the readied EVM, launch the software “calibrator-20121120.exe” in the folder “calibration-runtime” to start communicating with the EVM. A window as shown in [Figure 39](#) appears. As defined in the XML file “calibration-config.xml”, meter position 1 is assigned the serial port to communicate with the EVM. The *Comms* indicator will turn green if communication to EVM from PC is established, and it will flash between red and green when the communication takes place.



**Figure 39. Calibrator Software Startup Window**

Click on the *Comms* indicator to show the *Meter status* window as shown in [Figure 40](#).



**Figure 40. Meter Status Window**

This window shows the current reading of the meter. The background of a reading box is gray if the EVM does not support that particular reading. The box turns red if the reading from EVM to that box has a large variance, yellow if the reading from EVM has a fairly low variance, and green if the reading has a low variance.

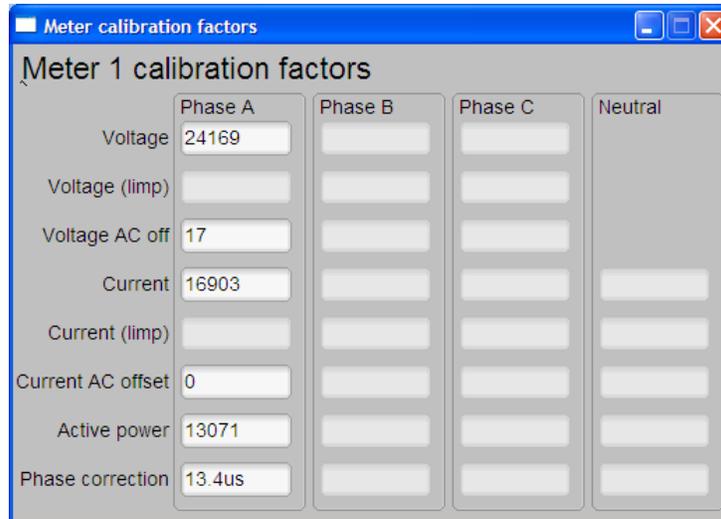
---

**NOTE:** The software on PC reads the EVM every second and averages the data read, meaning the update rate is slower than the update rate of the EVM.

---

At the bottom of this window, there are four buttons.

- The *Meter consumption* button brings up the *Meter consumption* window. This window gives no useful information because the EVM does not support this feature.
- The *Meter calibration factors* button brings up the *Meter calibration factors* window, which shows the current calibration factor values (see [Figure 41](#)).



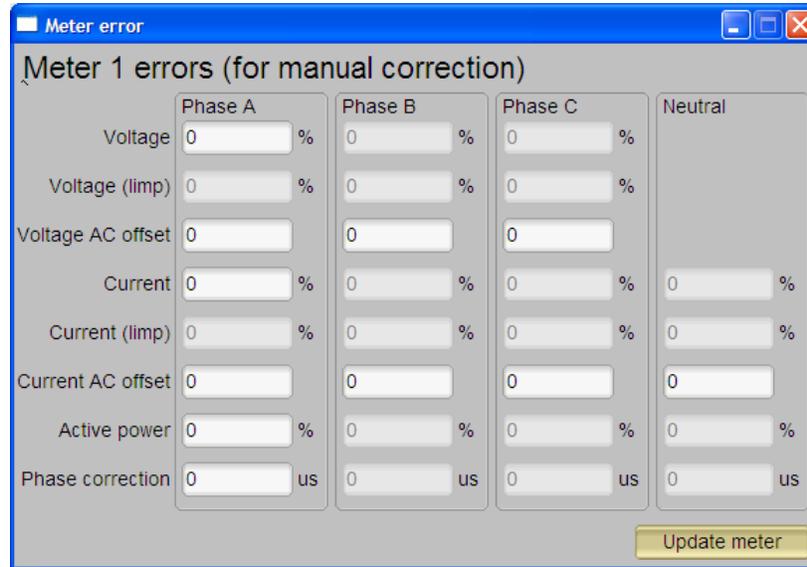
**Figure 41. Meter Calibration Factors Window**

- The *Meter features* button brings up the *Meter features* window. This window reports the support feature of the EVM (see [Figure 42](#), which only shows the look and feel of the *Meter features* window, not the exact feature of the EVM).



**Figure 42. Meter Features Window**

- Click on the *Manual cal* button brings up the *Manual cal* window (Figure 43). In this window, adjust the calibration factor values by entering the percentage error of the reading from the EVM and compare to the reading from the reference meter. The technique and procedure of performing calibration will be discussed in further detail in Appendix C.



The screenshot shows a window titled "Meter error" with a subtitle "Meter 1 errors (for manual correction)". It contains a table of input fields for calibration factors. The columns are labeled "Phase A", "Phase B", "Phase C", and "Neutral". The rows are labeled with measurement types: "Voltage", "Voltage (limp)", "Voltage AC offset", "Current", "Current (limp)", "Current AC offset", "Active power", and "Phase correction". Each cell contains a text box with the value "0" and a unit indicator (either "%" or "us"). A yellow "Update meter" button is located at the bottom right of the window.

**Figure 43. Meter Error Window**

To modify the calibration factor, enter the correction in the percentage error. The percentage error is calculated as follows:

$$\%Error = \frac{EVM\text{Reading} - ReferenceMeterReading}{ReferenceMeterReading} \times 100\% \quad (14)$$

Put the percentage error into its corresponding box in the *Meter calibration* window. Click *Update meter* to calculate and write the updated calibration values to the EVM. The corresponding values will be reflected on the *Meter calibration factor* window (Figure 41).

## B.5 Known Issues

The calibrator software is legacy software that operates with utility meters that have not been customized completely for embedded metering. The following is a list of known issues with the existing software that will be fixed in the next version of calibrator software customized for embedded metering.

- Neutral monitoring is shown in the *Meters features* window as a supported feature, which is incorrect. When wire resistance compensation or inlet capacitor compensation is enabled, the calibrator will interpret it as neutral monitoring support.
- Resistance values of wire resistance compensation and capacitance value of inlet capacitor compensation cannot be programmed with calibrator software.
- Voltage AC offset values cannot be written with the calibrator software. The value put into the voltage AC offset box is written to the current AC offset instead. The value put into the current AC offset box has no effect.
- DC offset values cannot be written to the EVM with the calibration software. The current firmware takes the current and voltage DC offset value every time any calibration value is updated.
- The aggregate current in *Meter status* windows always shows 10.0000 A.

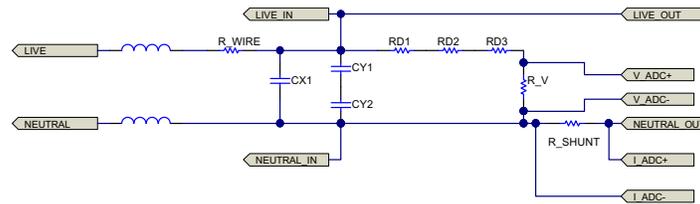
## Appendix C EVM Calibration

### C.1 Introduction

The EVM is programmed with calibration values that allow the EVM to give roughly accurate readings; however, the EVM has not been calibrated while shipped. To maximize accuracy and to compensate component and manufacturing tolerance, the EVM must go through a calibration process. This chapter will discuss the techniques, procedures, and steps of calibration.

### C.2 Calibration Techniques

The calibration of the EVM is defined based on the front-end interface model as shown in [Figure 44](#).



**Figure 44. Front-End Interface Model**

This design requires a two-point calibration. VGAIN, IGAIN, PGAIN, VDC\_OFFSET, and IDC\_OFFSET are parameters that will be calibrated during the process; an estimated value is put into the memory during the design and characterization to help to speed up calibration.

---

**NOTE:** Default CAP and RES should set to 0 before calibration.

---

VAC\_OFFSET, IAC\_OFFSET, PHASE\_CORRECT are parameters that may not need calibration but a characterization would be sufficient for embedded metering application except for a high accuracy of <0.1%.

---

**NOTE:** The calibration values are written in one flash page in the EVM, so when a new value needs to be written the whole page is erased. The provided GUI will do the read, modify, and write operations automatically. When using a user calibration facility, read the complete set of calibration values, back them up, update the modified field, and write the complete set back to the EVM.

---

## C.3 Calibration Procedures

### C.3.1 Calibration of AC and DC Parameters

Use the following steps to calibrate the AC and DC parameters.

#### Calibrating VGAIN

1. Set to *No/Lowest possible load*.
2. Set  $V_{IN}$  to line voltage.
3. Calculate the value for VGAIN with the formula

$$VGAIN_{n+1} = \frac{V_{REF}}{V_{UUT}} \times VGAIN_n$$

where

- $VGAIN_{n+1}$  is the new voltage calibration factor
- $VGAIN_n$  is the original voltage calibration factor
- $V_{REF}$  is the reference meter voltage reading at the voltage set for VGAIN calibration
- $V_{UUT}$  is the unit under test voltage reading at the voltage set for VGAIN calibration

(15)

or, if percentage error is used (as with the provided calibration software),

$$\%Error = \frac{V_{UUT} - V_{REF}}{V_{REF}} \times 100\%$$

(16)

4. Write and apply the calibrated VGAIN.

#### Calibrating IGAIN

1. Set  $V_{IN}$  to line voltage.
2. Set to *High / Highest possible load*.
3. Calculate IGAIN value with the formula

$$IGAIN_{n+1} = \frac{I_{REF}}{I_{UUT}} \times IGAIN_n$$

where

- $IGAIN_{n+1}$  is the new current calibration factor
- $IGAIN_n$  is the original calibration factor
- $I_{REF}$  is the reference meter current reading at the current set for IGAIN calibration
- $I_{UUT}$  is the unit under test current reading at the current set for IGAIN calibration

(17)

or, if percentage error is used (as with the provided calibration software),

$$\%Error = \frac{I_{UUT} - I_{REF}}{I_{REF}} \times 100\%$$

(18)

4. Write and apply the calibrated IGAIN.

#### Calibrating PGAIN

1. Use the same conditions as [Calibrating VGAIN](#) and [Calibrating IGAIN](#) with the power factor = 1.
2. Note the percentage error on voltage at this point.

3. Calculate PGAIN gain so that power is of the same percentage error as voltage at this point:

$$PGAIN_{n+1} = \frac{P_{REF}}{P_{UUT}} \times PGAIN_n \times (1 - \%Error \text{ of } V_{UUT} \text{ at this load})$$

where

- $PGAIN_{n+1}$  is the new power calibration factor
  - $PGAIN$  is the original power calibration factor
  - $P_{REF}$  is the reference meter power reading at the power set for PGAIN calibration
  - $P_{UUT}$  is the unit under test power reading at the power set for PGAIN calibration
- (19)

or, if percentage error is used (as with the provided calibration software),

$$\%Error = (1 + \%Error)(1 - \%Error \text{ of } V_{UUT} \text{ at this load})$$
(20)

4. Write and apply the calibrated PGAIN.

### C.3.2 Calibration of Compensation Resistance and Capacitance

After calibrating VGAIN, IGAIN, and PGAIN, follow these steps to calibrate the compensation to wire resistance and EMI capacitance.

#### Calibrating RES

1. Calculate RES with the given equation:

$$R_{WIRE} = \frac{V_{REF(I_{max})} - V_{UUT(I_{max})}}{I_{max} - I_{min}} \approx \frac{V_{REF(I_{max})} - V_{UUT(I_{max})}}{I_{max}}$$

where

- $R_{WIRE}$  is the estimated wire resistance
  - $V_{REF(I_{max})}$  is the reference meter voltage reading at the current set for IGAIN calibration
  - $V_{UUT(I_{max})}$  is the unit under test voltage reading at the current set for IGAIN calibration
  - $I_{max}$  is the current set for IGAIN calibration
- (21)

2. Write and apply the calibrated RES.

---

**NOTE:** The resistance is in 1/256-Ω units.

---

#### Calibrating CAP

1. Set to *No / Lowest possible load*.

2. Set *VIN* to low line voltage.

3. Calculate CAP with the given equation:

$$C = \frac{1}{2\pi fV^2} \left( \sqrt{P_{apparent\_REF}^2 - P_{active}^2} - \sqrt{P_{apparent\_UUT}^2 - P_{active}^2} \right)$$

where

- $C$  is the estimated EMI filter capacitance
  - $V$  is the voltage set for calibration of  $C$
  - $P_{apparent\_REF}$  is the apparent power reading of the reference meter at the setting for this calibration
  - $P_{apparent\_UUT}$  is the apparent power reading of the unit under test at the setting for this calibration
  - $P_{active}$  is the active power reading of the reference meter (suppose ut is already calibrated to be the same as the active power reading of UUT)
- (22)

4. Write and apply the calibrated CAP.

---

**NOTE:** The capacitance is in 1/64-μF units.

---

### C.3.3 Calibration of Current AC Offset

The current AC offset is the result of noise pickup, and the offset generated on the shunt resistor circuit causes an illusion of having a finite current flowing when there is actually not current flowing through the shunt. Although this noise current does not affect the power reading's accuracy, this illusion contributes to the current reading and its accuracy, especially when the current is small. To offset this miscalculation, the EVM firmware has the mechanism to remove this from the current reading. The steps to calibrate this current offset are as follows:

1. Apply nominal voltage to make sure the EVM operates.
2. Remove all loading from the EVM.
3. Take multiple current readings (for example, 100) and take an average as I\_NOISE (in A).
4. Calculate the current AC offset value with the equation

$$I\_AC\_OFFSET = \text{int} \left[ I\_NOISE \left( \frac{1024 \times 10^6}{IGAIN} \right) \right]^2 \quad (23)$$

---

**NOTE:** This is a big number even in the case of a few mA of noise.

---

5. Write and apply the calibrated I\_AC\_OFFSET.

### C.3.4 Calibration of Voltage AC Offset

In most cases, the voltage AC offset rarely affects the voltage reading and does not require calibration.

### C.3.5 Calibration of Phase Correction

1. Set the test set to generate rated voltage and set to calibration current (for example, 5 A).
2. Make sure calibrations are complete for PGAIN (at PF = 1).
3. Set the test set to output at power factor 0.5 (+ or – is not important at this point).
4. Note the power error.
5. Switch the test set to output at power factor 0.5 in the other direction to [Step 3](#).
6. Note the power error.
7. At this point, both power errors should be approximately the same deviation but a different direction from the calibrated power error at PF = 1.
  - For example, at PF = 1, the calibrated error is 0.1%. If at PF = 0.5, the power error reads about 0.5%. Then at PF = –0.5, the power error should read about –0.3%.
8. Adjust the phase correction with time deviation from the current phase correction such that the power errors at PF = ±0.5 are minimized.
  - For example, if the current phase correction is 13 μs and 11 μs is desired, enter –2 into the phase correction box of the manual calibration window.

### C.3.6 Calibration of DC Parameters

This EVM design calibrates the AC and DC measurement parameters simultaneously. The DC measurement parameters update automatically in the last step of calibration.

In fact, whenever the complete set of calibration values is read, the most up-to-date DC measurement parameters are also included in the set. When other parameters update, the DC measurement parameter also update to the most current value. However, the value is most accurate when current is low (best with not current at all). As such, update the DC measurement parameter after the I\_AC\_OFFSET calibration.

---

**NOTE:** This may not be a user friendly way of setting DC measurement parameters. The procedure of having the best DC measurement parameters will be modified and improved when the embedded metering customized calibration software is released.

---

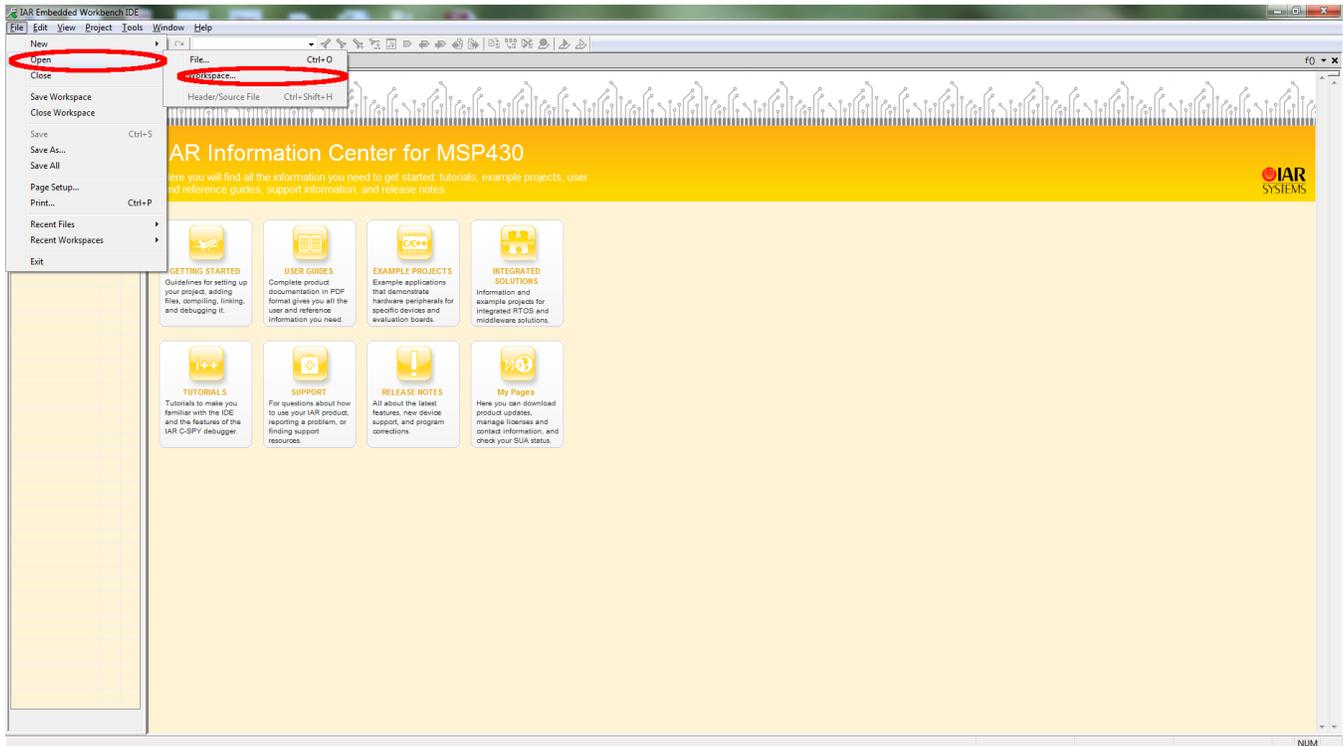
## Appendix D EVM Specification

- Voltage operating range (with supplied power supply): 85 to 265-V AC, 120 to 380-V DC
- Sample rate: 8000 Hz
- Sampling bit depth: 24 bits
- Polling report supported
- Update rate: Four AC cycles (AC mode), 80 ms (DC mode)
- UART communication data rate: 9600 bps
- AC/DC measuring mode switching: Four AC cycles (AC to DC), 80 ms (DC to AC)
- Measurements: RMS voltage, RMS current, active power, reactive power, apparent power, power factor, line frequency, and temperature
- Measurement voltage range: 0 to 265 V<sub>RMS</sub> AC, 0 to ±380-V DC (using reference design circuit and component values)
- Measurement current range: 0 to 15 A<sub>RMS</sub> AC, 0 to ±22.5-A DC (using reference design circuit and 0.5-mΩ shunt values)
- Voltage resolution: 1 mV
- Current resolution: 1 μA
- Active Power resolution: 1 mW
- Reactive/apparent power resolution: 1 mW
- Power factor resolution: 0.001
- Frequency resolution: 0.01 Hz

## Appendix E Running on MSP430i2040 and MSP430i2041

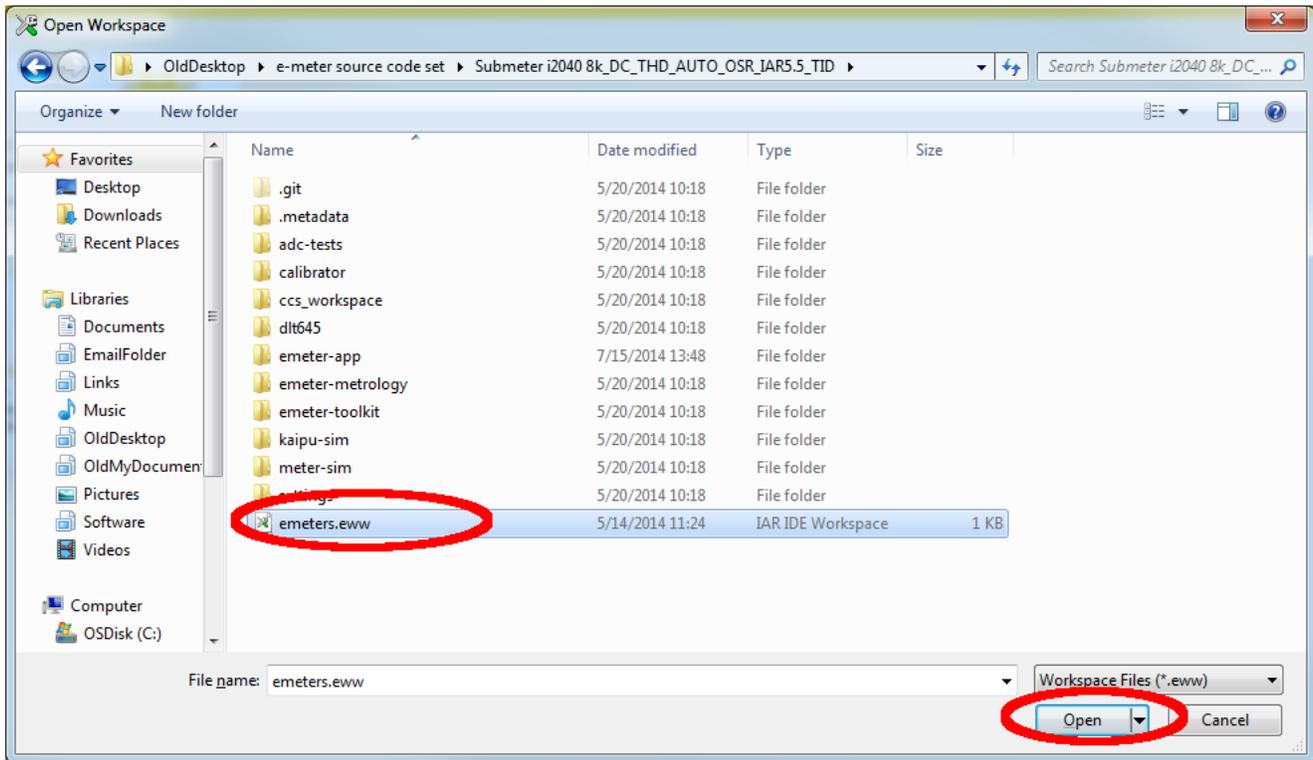
The example IAR project has been configured for MSP430i2041. To run on MSP430i2040, follow these steps once:

1. Open the workspace. After launching IAR 5.5, select *File*→*Open*→*Workspace*.



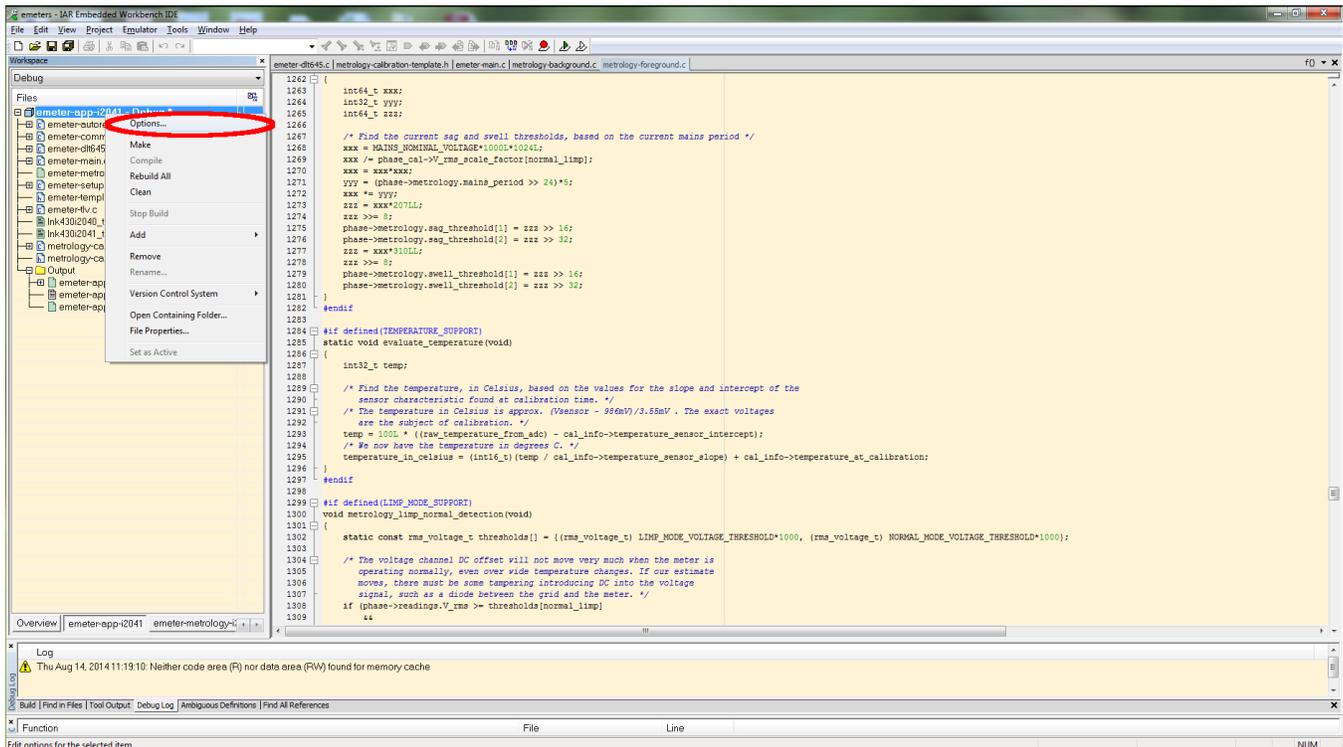
**Figure 45. IAR 5.5 Launch Window**

When prompted to open the project, select *emeters.eww* from the project directory of the example code.



**Figure 46. Open Workspace Window**

2. Set the option. Right click on the project *emeter-app-i2041* and select *Options...*



**Figure 47. Workspace Options**

In the *Options* window, click on *General Options* on the left-hand column and then select the *Target* tab. Then, in the *Device* section, click on the right-hand side button of the entry box and select *MSP430xxxx Family*→*MSP430I2040*.

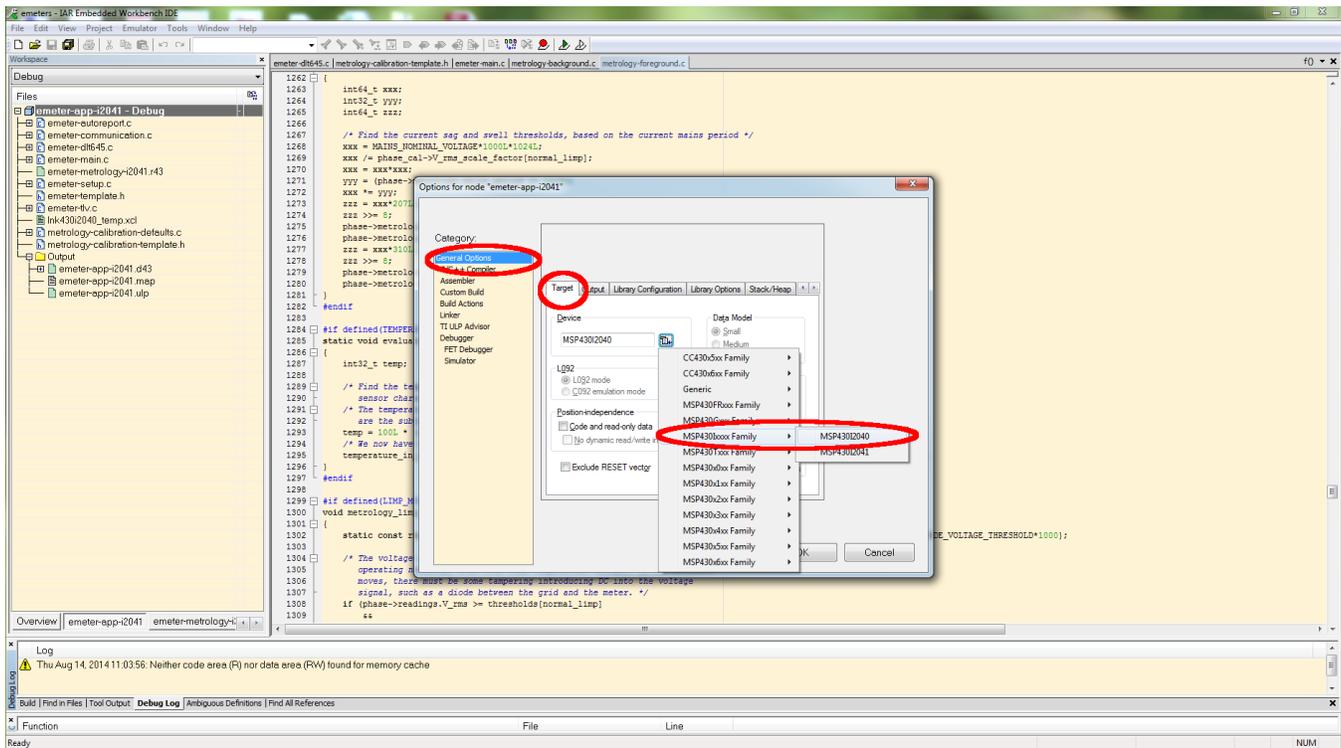


Figure 48. Options Window

Click on *Linker* in the left-hand column and select the *Config* tab. Then click on the right-hand button in the *Linker configuration file* box.

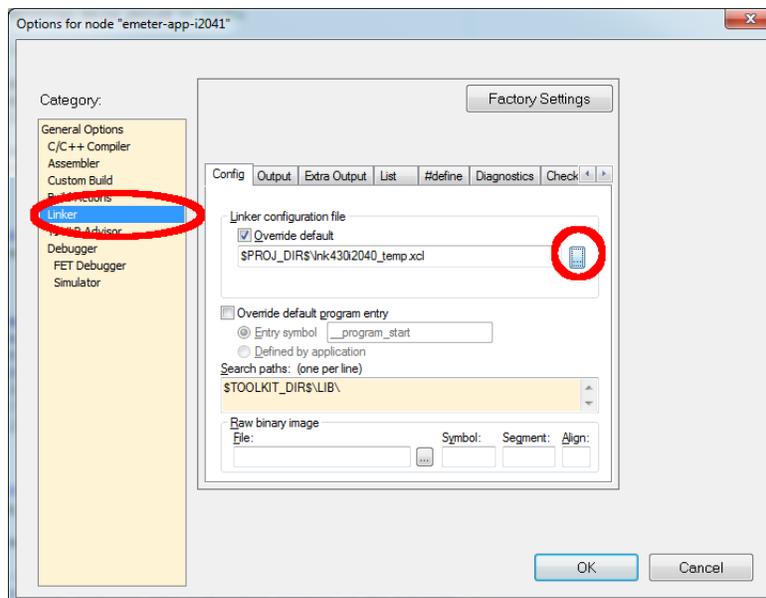
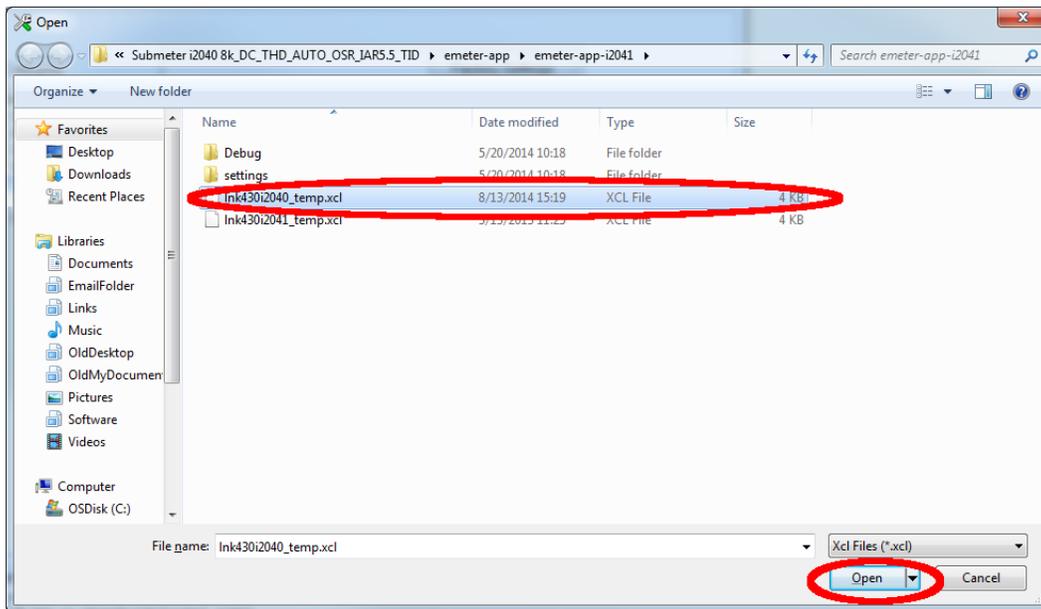


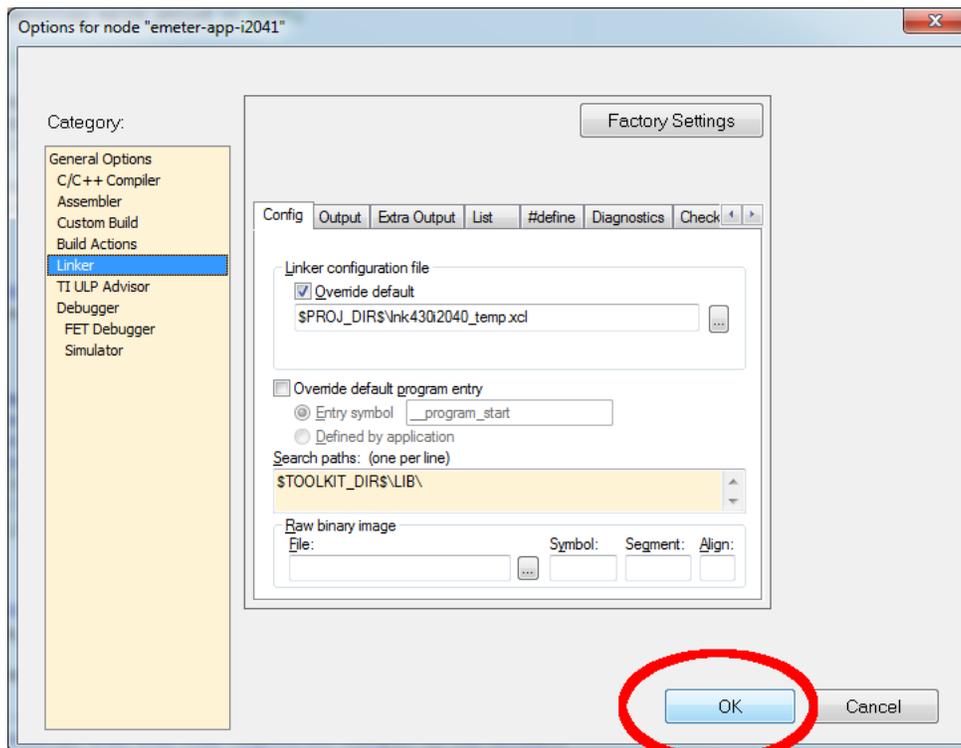
Figure 49. Config Tab

Select *Ink430i2040\_temp.xcl* when prompted and click *Open*.



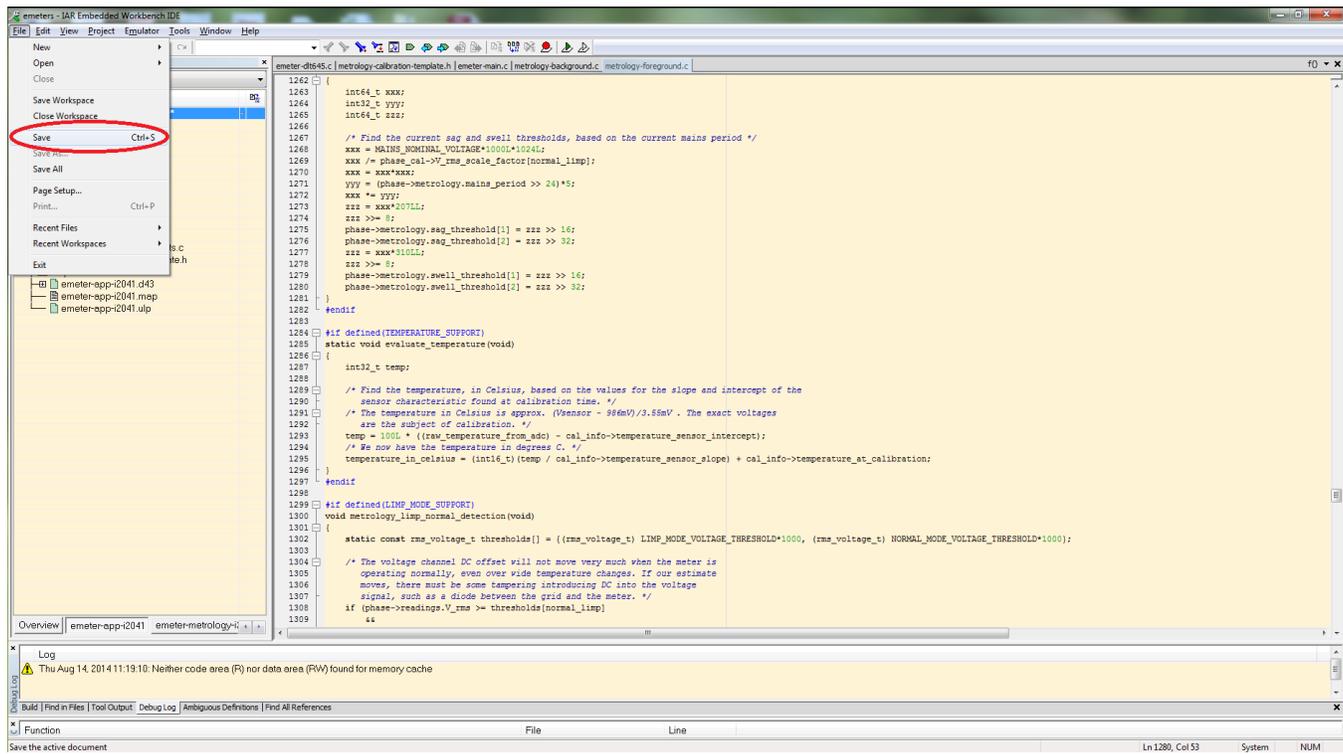
**Figure 50. Selecting Default XCL File**

When brought back to the *Options* window, click *OK*.



**Figure 51. Finishing the Setting Changes**

When brought back to the main screen, select *File*→*Save* to save the setting.



**Figure 52. Saving the Setting Changes**

The project is now set for run on MSP430i2040. To have the project to run back on MSP430i2041, follow the same steps except select *MSP430ixxx Family*→*MSP430i2041* in the *Options* window and select *Ink430i2041\_temp.xcl* when prompted in the *Linker configuration file* box.

## Revision History

### Changes from Original (August 2014) to A Revision

**Page**

- 
- Added Appendix E to explain how to run a project on MSP430i2040 ..... [44](#)
- 

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

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